

Materials Characterization - Product Catalog

Multifields Technologies | Beijing

MultiFields &Group

Content		Page	Content	Pa
1	Electrical Transport Measurement	1-20	2 - 4 Thermal Measurement	21-4
	1.1 General ETM Module Cover conventional electrical measurements such as resistance, Hall, etc.	2	Thermal Transport Measurement (TTM) Solution for thermal conductivity, Seebeck and resistance measurement	22
	1.2 Single Axis Rotation ETM Rotating ETM probe allows for 360° sample rotation along a single axis	5	TTM Meter 2.1 Built-in thermocouple and thermometer monitoring module for precise control of thermal gradients	23
	1.3 Dual Axis Rotation ETM Completely cover three-dimensional space sphere	10	TTM Probe 2.2 The TTM probe with a 2-K in-situ vacuum chamber guarantees no heat leakage caused by gas flow around sample.	25
	1.4 ETM Accessories Essential options for electric transport measurement	14	TTM Accessories 2.3 TTM requires skilled operation and well-prepared experimental accessories for higher accuracy	27
	Matrix Switch System 1.4.1 Arbitrarily switch the connection between the source meter and the device	15	TTM Software 2.4 Sequence-written interfaces can conduct the flexible measurement	29
	Breakout Box with ESD Protection 1.4.2 Low leakage current guarantees a higher signal accuracy and better resolution.	17	2.5 TTM - Application :	30
	Check Stage 1.4.3 Flexible desktop breakout box for device measurements anytime & anywhere	18	Heat Capacity Measurement (HCM) Solution for heat capacity measurement	32
	1.4.4 ETM Accessories Options for Electric Transport Measurement	20	HCM Meter 3.1 Built-in heating and high-speed temperature monitoring channels, collecting temperature changes for real-time fitting	33

MultiFields &Group

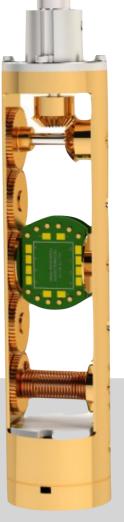
Content			Page	Content		Page
2 - 4		Thermal Measurement	21-45	5	Magnetic Measurement	46-58
	3.2	HCM Probe The TTM probe with a 2-K in-situ vacuum chamber guarantees no heat leakage caused by gas flow around sample.	34		VSM Measurement System 5.1 Complete system including probe, controller and measurement software for magnetic moment measurement	;
	3.3	HCM Accessories Specific heat capacity measurement is made easy with specialized mounting tools and accessories.	35		ACMS Measurement System	
	3.4	HCM Software Sequence-written interfaces can conduct the flexible measurement	36		ACMS Measurement System 5.2 Complete system including probe, controller and measurement software for AC susceptibility measurement	
	3.5	HCM - Application	37	Ę	Magnetic Measurement Accessories 5.3 Magnetic measurement is made easy with specialized mounting tools and accessories. 58	
	4 Therma Solution fo	al Expansion Measurement (ThE) r thermal expansion and magnetostriction measurement	40	6 - 8	Magnetoelectric Measurement	59-68
	4.1	ThE Cell Highly precise capacitive position sensor monitors sample size variation	41		Dielectric Measurement 6 Compatible with dielectric, ferroelectric, pyroelectric, etc. measurements for bulks and films	J
	4.2	ThE Accessories Dedicated room temperature installation & calibration tool	42		Ferroelectric Measurement	
	4.3	ThE Software Sequence-written interfaces can conduct the flexible measurement	43		7 Complete system including probe, analyzer and software for ferromagnetic measurement 63	
	4.4	ThE - Application	44		Magnetoelectric Coupling Measurement Magneto-electric coupling coefficient measurement system with ultra-high sensitivity 67	

Conten	it			Page
9	— Dan	Ferromagnetic Resonance (FMR) Measurement		69-75
	9.1	FMR Workstation Integrating FMR, ST-FMR, Spin Pumping & ISHE into one system and exhibiting extraordinary sensitivity to measure magnetic film.	71	
	9.2	FMR Measurement High-frequency measurements on thin-film samples, with sample perpendicular/parallel to magnetic field configurations	73	
	9.3	ST-FMR Measurement High-frequency measurements on thin-film samples, with sample perpendicular/parallel to magnetic field configurations	75	
10		Confocal Optical Measurement		77-88
	10.1	Stackable Function Module - Raman / Fluorescence Spectroscopy	78	
	10.2	Stackable Function Module - Magneto Optical Kerr Effect (MOKE)	80	
	10.3	Confocal Probe Suitable for cryogenic confocal measurement and compatible with the most superconducting magnet platforms	83	
	10.4	Low-Temperature Objective Optical objective for long-time stable working at low temperature	84	

MultiFields & Group

Conte	ent			Page
	10.5	Sample Mount Flexible and convenient sample mounting for combined optical-electric measurements	85	
	10.6	Nano Motion Units Ultra-precise nano-motion units using in minimum dia.26mm chamber	86	
11		General Instrument		89-89
	11	Kelvinion Temperature Monitor & Controller	89	





Single Axis Rotation ETM.RotProbe.30

MultiFields 多场科技

Dual Axes Rotation ETM.3DRotProbe.50

Electrical Transport Measurement Module







Electric Transport Measurement Series







Single Axis Rotation - ETM.RotProbe.xx.xx



Dual Axes Rotation - ETM.3DRotProbe.xx.xx

General DC & AC measurements can be realized.

Sample can be rotated along a single axis.

Integrate a piezoelectric rotator on the mechanical axis.

Dameter Dame	Functions	General DC & AC measurements can be realized. Fiber, high voltage, coaxial cable and DAC are compatible.	Sample can be rotated along a single axis. High voltage, coaxial cable and DAC are compatible.	Integrate a piezoelectric rotator on the mechanical axis. Completely cover three-dimensional space sphere.			
Range Limitless 0 ~ 370 ° Piezoelectric - 20 ~ 200 ° (aia-30 mm) - 30 ~ 30 ° (dia-50 mm) Precision Limitless 0 11 ° Mechanical: 0.1 °, Piezoelectric: - 20 ~ 200 ° (aia-30 mm) - 30 ~ 30 ° (dia-50 mm) Withstand voltage 200 V Leakage current - 200 V Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 12/16 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) Sample holder - 200 V PCB Compatible - 200 V Compatible - 200 V LCC 28 - 200 mm, dia-30 mm ompatible - 200 pA @ 100 V LCC 44 Only dia 50 mm compatible - 200 pA @ 100 p	1 Work environment	Temperature: 1.4 K \sim 400 K; Pressure: 10 ⁵ \sim 10 ⁻⁵ Pa; Magnetic Field: 0 \sim 18 Tesla;					
Range Limitless 0 ~ 370 ° Piezoelectric: ~20 ~ 200 ° (dia-30 mm) -30 ~ 300 ° (dia-50 mm) -30 ~ 300 ° (2 Diameter						
Prezidentic: -20 ~ 200 ° (dia -30 mm) -30 ~ 300 ° (dia -50 mm) Prezidentic: -20 ~ 200 ° (dia -30 mm) -30 ~ 300 ° (dia -50 mm) Withstand voltage Limitless 0.1° Mechanical: 0.1°; Prezoelectric: < 0.01° Leakage current Channel (STD/MAX) 12/24 (dia -26 mm, dia -30 mm) & 24/48 (dia -50 mm) 7 Sample holder PCB Compatible N.A. DIP 16 Compatible Compatible Compatible Compatible Compatible Compatible Compatible N.A. N.A.	3 Rotation	manually fix sample direction	Single mechanical rotation axis	Mechanical rotation axis & Piezoelectric rotation axis			
Withstand voltage Leakage current Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 200 V Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 12/16 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) Compatible Compatible Compatible Only dia-50 mm compatible N. A DIP 16 Compatible Compatible Compatible Only dia-50 mm compatible Only dia-50 mm compatible N. A Vacuum option upgrade	Range	Limitless	0 ~ 370°	Mechanical: 0 \sim 370 ° Piezoelectric: -20 \sim 200 ° (dia-30 mm) -30 \sim 300 ° (dia-50 mm)			
Leakage current Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 25 Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 12/16 8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm) 26 Sample holder PCB Compatible Compatible Compatible Compatible Compatible Only dia-50 mm compatible Only dia-50 mm compatible N.A. DIP 16 Compatible Compatible Only dia-50 mm compatible Only dia-50 mm compatible N.A. Vacuum option upgrade Vacuum option upgrade	Precision	Limitless	0.1 °	Mechanical: 0.1 °; Piezoelectric: < 0.01 °			
Channel (STD/MAX) 12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm) 12/16 Sample holder PCB Compatible Compatible CC28 Compatible CC44 Only dia-50 mm compatible COmpatible Only dia-50 mm compatible COmpatible Only dia-50 mm compatible N. A. DIP 16 Compatible Compatible Compatible Only dia-50 mm compatible N. A. Vacuum option upgrade Vacuum option upgrade	4 Withstand voltage		200 V				
Sample holder PCB Compatible Compatible Compatible Only dia-50 mm compatible Only dia-50 mm compatible LCC 28 Compatible Only dia-50 mm compatible LCC 44 Only dia-50 mm compatible Only dia-50 mm compatible DIP 16 Compatible Compatible Only dia-50 mm compatible 3 Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) Vacuum option upgrade Vacuum option upgrade	5 Leakage current		< 100 pA @ 100 V				
PCB Compatible Compatible Compatible Compatible Compatible LCC 28 Compatible Only dia-50 mm compatible Only dia-50 mm compatible LCC 44 Only dia-50 mm compatible Only dia-50 mm compatible DIP 16 Compatible Compatible Only dia-50 mm compatible 3 Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) 7 Vacuum option upgrade	6 Channel (STD/MAX)	12/24 (dia-26 mm, dia-30 mm) & 24/48 (dia-50 mm)	12/16	8/8 (dia-26 mm, dia-30 mm) & 16/16 (dia-50 mm)			
LCC 28 Compatible Only dia-50 mm compatible Only dia-50 mm compatible LCC 44 Only dia-50 mm compatible Only dia-50 mm compatible DIP 16 Compatible Compatible Only dia-50 mm compatible 3 Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) Vacuum option upgrade	7 Sample holder		see the sample holders brochure for details				
LCC 44 Only dia-50 mm compatible Only dia-50 mm compatible N. A. DIP 16 Compatible Compatible Only dia-50 mm compatible 3 Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) Vacuum option upgrade	PCB	Compatible	Compatible	Compatible			
DIP 16 Compatible Compatible Only dia-50 mm compatible Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) Vacuum option upgrade	LCC 28	Compatible	Only dia-50 mm compatible	Only dia-50 mm compatible			
Coaxial cable upgrade 2 (dia-26 mm, dia-30 mm) & 4 (dia-50 mm) N. A. Vacuum option upgrade	LCC 44	Only dia-50 mm compatible	Only dia-50 mm compatible	N.A.			
9 Vacuum option upgrade	DIP 16	Compatible	Compatible	Only dia-50 mm compatible			
	8 Coaxial cable upgrade	2 (dia-26 mm, dia-30	mm) & 4 (dia-50 mm)	N. A.			
O Compatible options Matrix Switch System, Breakout Box, Check Stage and ETM Accessories are compatible for all above products.	9 Vacuum option upgrade						
	10 Compatible options	Matrix Switch System, Breakout Box, Check Stage and ETM Accessories are compatible for all above products.					

^{*} The Multifields Technologies ETM series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others:

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.

•

■ Electric Transport Measurement (ETM)

1.1 General ETM probe - Overview

Cover conventional electrical measurements such as resistance, Hall, etc., provide the options of optical fiber, high voltage and small signal measurement.



Multifields Technologies® general ETM probes with multifunctional plate for fitting different feedthroughs, such as the commonly used LEMO, Fischer, mil-spec connectors, etc... Coaxial Feedthroughs such as BNC, SMA, 2.92 connectors (40GHz) are also available as an option.

Key Features

- Sample direction can be freely fixed;
- Withstand voltage > 200 V (DC);
- Excellent leakage current;
- Provide vacuum options;

- Compatible with a variety of sample holders;
- Provide coaxial cable for option;
- Working temperature: 1.5~400K; Field: 18 Tesla;
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms

1.1 General ETM probe - Models

General ETM probes with multiple functional options for cryogenic chambers with different bore sizes

Model Details - General ETM probe



	Chamber ¹	Sample Holder ²	Vacu	um Environmei	nt ³	Slide	Seal ⁴	Options ⁵
	.25C	.MF12/ .MF16/ .LCC20		/		.SS	.SL	
	.26P			/			/	
	.26	.MF12/ .MF16/ .DIP16/ .LCC20/ .LCC28 —		/			/	.CX
ETM.MCProbe	.30		.cone	/			/	.Cn
	.30C		.cone	/		.SS	.SL	.OF
	.50	.MF12/ .MF16/ .MF24/ .DIP16/ .LCC20/ .LCC28/ .LCC44	.cone	.ln	/		/	
	.50C		.cone	.ln	/		SL	

¹ Chamber: .26P - QD PPMS; .26/.30/.50 - Platforms with dia-26/30/50 mm chambers such as Oxford-TeslatronPT、Pride-CPMS; .25C/.30C/.50C - Cryogenic with dia-26/30/50 mm chambers;

→Recommend Models:

- ETM.MCProbe.26P.MF12
- ETM.MCProbe.26P.2MF12
- ETM.MCProbe.26P.MF16
- ETM.MCProbe.26P.MF12.OF

- ETM.MCProbe.26P.MF16.OF
- ETM.MCProbe.26P.LCC28
- ETM.MCProbe.26P.DIP16
- ETM.MCProbe.30.MF12.CX

- ETM.MCProbe.30.2MF12.CX
- ETM.MCProbe.30.MF16.CX
- ETM.MCProbe.30.MF12.CX.OF
- ETM.MCProbe.30.MF16.CX.OF

- ETM.MCProbe.50.2MF12.CX
- ETM.MCProbe.500.MF16.CX
- ETM.MCProbe.50.MF12.CX.OF
- ETM.MCProbe.50.MF16.CX.OF

² Sample Holder: .MF12/16/24 - MF PCB12/16/24pin sample holders; .DIP16 - DIP - 16pin chip carrier; .LCC20/28/44 - LCC - 20/28/44pin chip carrier;

³ Vacuum Environment: .Cone - Conical seal; .In - Indium wire seal; / - No vacuum required;

⁴ Slide Seal: .SS - Cryogenic original slide seal; .SL - MF slide seal & airlock; / - No slide seal required;

⁵Options: .CX - Cernox temperature sensor..Cn - Upgrade n pcs of coaxial cables; .OF - Optical fiber; / - No option required;

^{*} This table is used as a guide for selecting general ETM probes. For specific selections or other options, please consult the sales staff of Multifields Technologies.

1.1 General ETM probe - Application

Designed for low-level signal measurements with ease and convenience

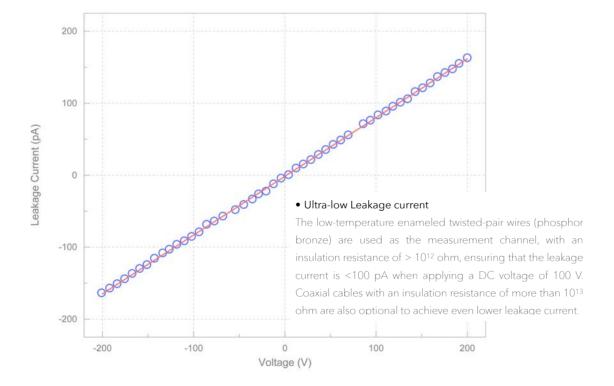
Application (1)-

Leakage Current Test

Sample Information None General ETM probe (ETM.Probe.26P) MultiFields Products Angilent B1500 Platform None

Method

Without installing the sample, two channels remain disconnected from each other. Apply a voltage and measure the current between the two channels. We chose Agilent B1500 semiconductor analyzer for a reliable result.



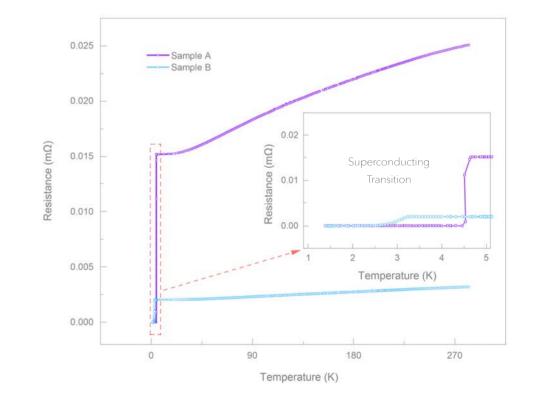
Application (2)-

Transition temperature of superconducting materials



Method

The four-wire method is used to measure the resistance of the sample. In order to obtain an accurate resistance value and exclude the noise, the positive and negative currents are applied alternately.



1.2 Single Axis Rotation ETM - Overview

Rotating ETM probe allows for 360° sample rotation along a single axis.



ETM.RotProbe.30.MF12



ETM.RotProbe.30.MF16



ETM.RotProbe.50.DIP16



ETM.RotProbe.50.LCC44

Key Features

- Excellent leakage current;

- Compatible with a variety of sample holders;
- Working temperature: 1.5~400K; Field: 18 Tesla;
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and

■ Electric Transport Measurement (ETM)

1.2 Single Axis Rotation ETM - Models

Single axis rotation ETM probes with multiple functional options for cryogenic chambers with different bore sizes

Model Details - Single Axis Rotation ETM probe



ETM.RotProbe.aa.bb.cc.dd.ee.ff

	Chamber ¹	Sample Holder ²	Vacuu	um Environme	nt ³	Slide	e Seal ⁴	Options ⁵
	.25C	.MF12/ .MF16		/		.SS	.SL	
ETM.RotProbe	.26P			/			/	
	.26	.MF12/ .MF16/ .DIP16/ .LCC20		/			/	
	.30		.cone	/			/	.CX .Cn
	.30C		.cone	/		.SS	.SL	.CH
	.50	.MF12/ .MF16/ .MF24/ .DIP16/ .LCC20/ .LCC28/ .LCC44	.cone	.ln	/		/	
	.50C		.cone	.ln	/		SL	

¹ Chamber: .26P - QD PPMS; .26/.30/.50 - Platforms with dia-26/30/50 mm chambers such as Oxford-TeslatronPT、Pride-CPMS; .25C/.30C/.50C - Cryogenic with dia-26/30/50 mm chambers;

→Recommend Models:

- ETM.RotProbe.26P.MF12
- ETM.RotProbe.26P.MF16
- ETM.RotProbe.30.MF12.CX
- ETM.RotProbe.30.MF16.CX

- ETM.RotProbe.50.MF12.CX
- ETM.RotProbe.50.MF16.CX
- ETM.RotProbe.30C.MF12.SS.CX
- ETM.RotProbe.30C.MF16.SS.CX

- ETM.RotProbe.30C.MF12.SL.CX
- ETM.RotProbe.30C.MF16.SL.CX
- ETM.RotProbe.50C.MF12.SS.CX
- ETM.RotProbe.50C.MF16.SS.CX

- ETM.RotProbe.50C.MF12.SL.CX
- ETM.RotProbe.50C.MF16.SL.CX

² Sample Holder: .MF12/16/24 - MF PCB12/16/24pin sample holders; .DIP16 - DIP - 16pin chip carrier; .LCC20/28/44 - LCC - 20/28/44pin chip carrier;

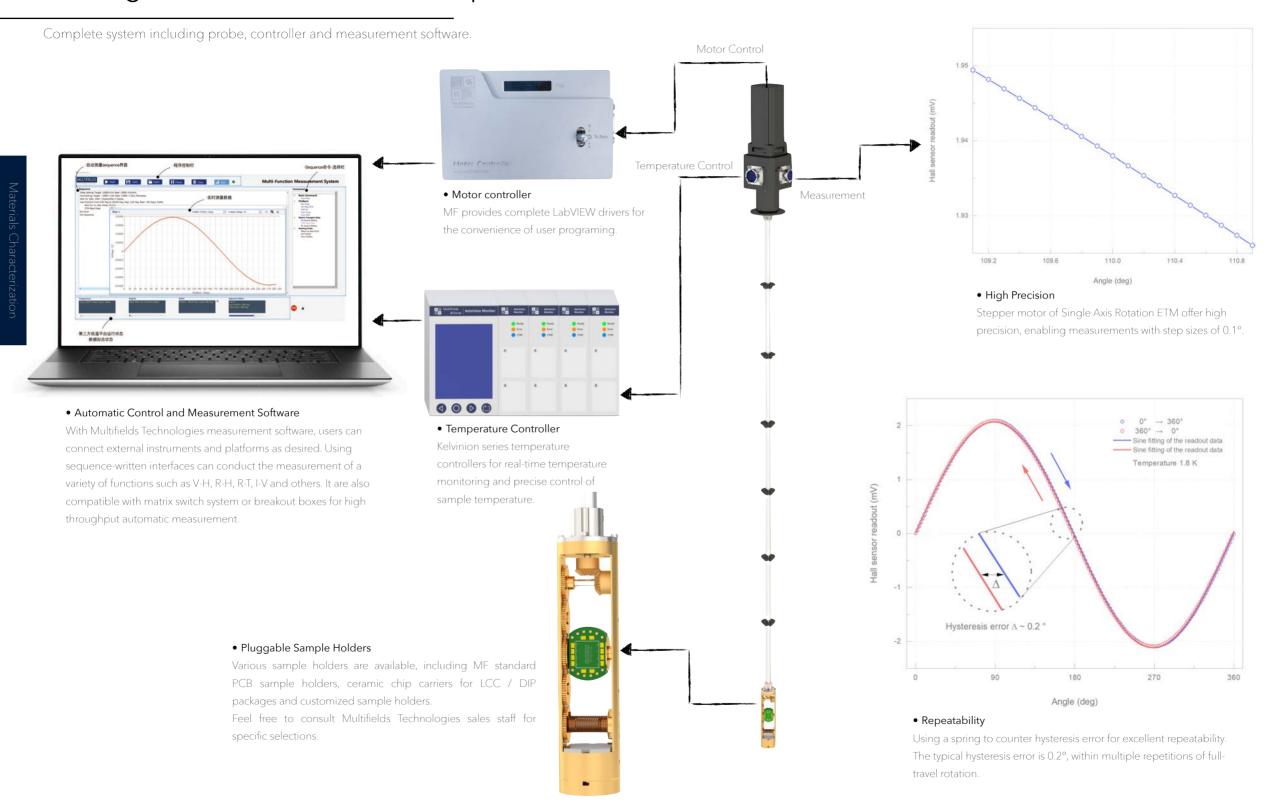
³ Vacuum Environment: .Cone - Conical seal; .In - Indium wire seal; / - No vacuum required;

⁴ Slide Seal: .SS - Cryogenic original slide seal; .SL - MF slide seal & airlock; / - No slide seal required;

⁵ Options: .CX - Cernox temperature sensor..Cn - Upgrade n pcs of coaxial cables; .OF - Optical fiber; / - No option required;

^{*} This table is used as a guide for selecting general ETM probes. For specific selections or other options, please consult the sales staff of Multifields Technologies.

1.2 Single Axis Rotation ETM - Components



1.2 Single Axis Rotation ETM - Applications

Application (1)-

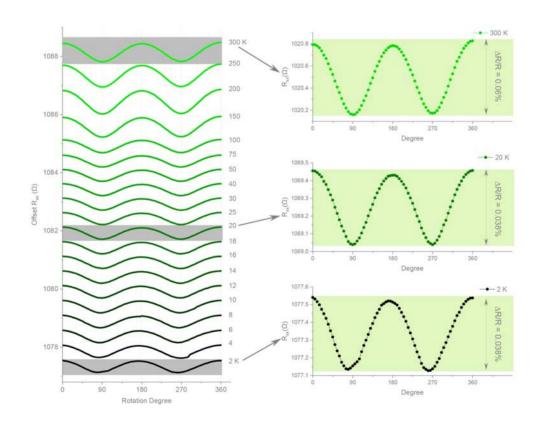
Spin Hall magnetic field angle dependence at different temperatures

Sample Information W(5)/CoFeB(0.9)/MgO(2)/Ta(2 nm)

MultiFields Products

Electric Meters

- 1. ETM.RotProbe.30.MF12
- 2. MF.Breakout Box.Pro.Max
- 1. Keithley 2182A
- 2. Keithley 6221



Application (2)-

The magnetic field angle dependence on the second harmonic electric transport measurement

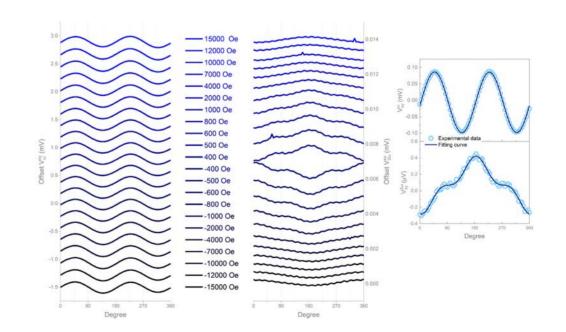
Sample Information Co(3nm)/Pt(5 nm)

MultiFields Products

- 1. ETM.RotProbe.30.MF12
- 2. MF.Breakout Box.Pro.Max

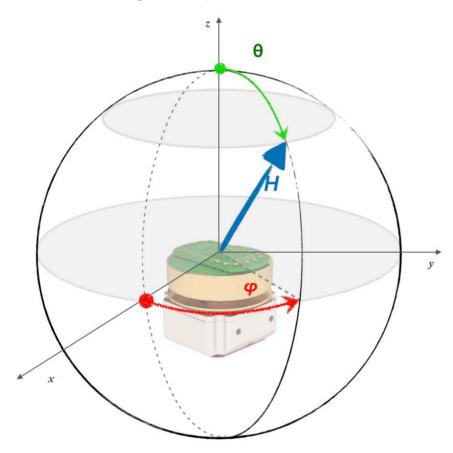
1. Stanford SR830 *2 Electric Meters

2. Keithley 6221



1.3 Dual Axis Rotation - Overview

Completely cover three-dimensional space sphere (using 3D polar coordinates to name rotation angle, theta & phi).



• Completely cover three-dimensional space sphere

The direction between magnetic field and the sample could be rotated through rotating the sample. The mechanical axis is fixed and the piezoelectric axis is the following axis. If we consider the orientation of the magnetic field with respect to the sample, as shown in the figure above, the two angles of the spherical coordinates: the elevation angle θ corresponds to the mechanical axis angle, and the azimuth angle ϕ corresponds to the piezoelectric axis angle.



Features

- Mechanical axis rotation range: -10° to 370°;
- Piezo rotator with closed-loop control and 0.01° resolution
- Maximum withstand voltage: 200 V (DC);
- Excellent leakage current;
- Compatible with vacuum option;

- Compatible with various sample holder: PCB, LCC & DIP customization;
- Support upgrade of high-precision and low-noise coaxial cable:
- Operating temperature 1.5 to 400K; Maximum
- Compatible with QD-PPMS Dynacool, Oxford
 TeslatronPT, Cryogenic and Pride CPMS system, etc.



Dual Axis Rotation · ETM

Functions: resistance / Hall (I-V, R-T, R-H, etc.), van de Paul, lock-in (AC resistance / Hall, harmonic) measurement





Dual Axis Rotation (ETM.2DRotProbe.30.MF8)

Dual Axis Rotation (ETM.2DRotProbe.50.MF16)

1 Work environment	Temperature: 1.4 K \sim 400 K; Pressure: $10^5 \sim 10^{15} \text{Pa}$; Magnetic Field: $0 \sim 18 \text{Tesla}$;					
2 Diameter		dia-26 mm / dia-30 mm / dia-50 mm				
3 Rotation		Integrated piezoelectric rotator on a mechanical ro	otating axis, rotation range cover a complete sphere			
Range	mechanical axis	0° ~ 370°	0° ~ 370°			
Range	Piezoelectric axis	-20° ~ 200°	-30° ∼ 300°			
Precision	mechanical axis	mechanical axis 0.1°				
FICCISION	Piezoelectric axis	Piezoelectric axis < 0.01°				
4 Withstand voltage	200 V					
5 Leakage current		< 100 pA @ 100 V				
6 Channel (STD/MAX)		8	16			
7 Sample holder		see the sample holde	ers brochure for details			
РСВ		Only MF8	Only MF12 / MF16			
LCC 28		N. A.	Compatible			
LCC 44		N. A.	N. A.			
DIP 16		N. A.	Compatible			
8 Coaxial cable upgrade	2		4			
9 Vacuum option upgrade	Compatible		Compatible			
10 Compatible options		MF. Breakout Box; MF.CheckStage; MF.Matrix.6-24 etc.				

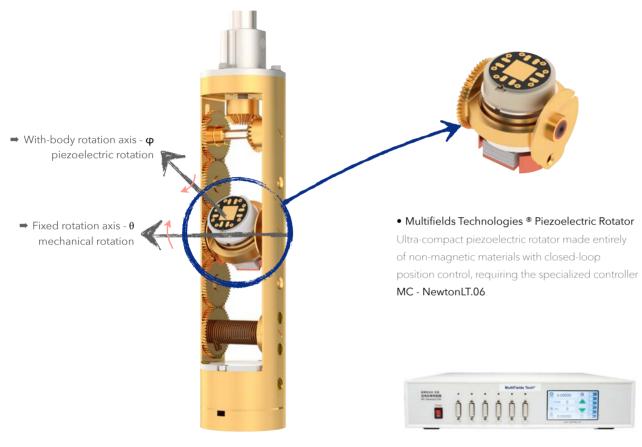
^{*} The Multifields Technologies ETM series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others;

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.

■ Electrical Transport Measurement (ETM)

1.3 Dual Axis Rotation - Key Parts

Piezoelectric rotator with 16 mm size, compatible with the chamber of dia.26~30 mm



ETM.2DRotProbe.30.MF8

Multifields Technologies ® Piezoelectric Motion
Piezoelectric Motion Controller

MC - NewtonLT.06



• Sample holder, 8 channels (.MF8)



• PEEK sample holder



• Mechanical base



Rotator.16.SE
 16 mm Piezoelectric rotator
 Multifields Technologies - Piezoelectric Motion Product

Rotator.16.SE - Specifications

	Temperature: 1.4 ~ 400 K;	5. Driving Voltage	20V ~ 200 V
1. Work environment	Pressure: 1 × 10 ⁻⁷ mbar;	6. Max. Load	100 g
	Max. Field: 35 Tesla	7. Sensor	Resistance sensor
2. Weight	10 g	8. Sensor Range	270°
3. Range	-20° ~ 200°	9. Sensor Precision	0.01°
4. Max. Speed	~ 10 °/s @300 K	10. Repeatability	~ 0.05°

■ Electrical Transport Measurement (ETM)

1.3 Dual Axis Rotation - Key Parts

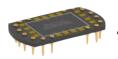
Piezoelectric rotator with 25 mm size, compatible with the chamber of dia.50 mm



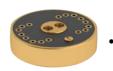
ETM.2DRotProbe.50.MF16

Multifields Technologies ® Piezoelectric Motion
Piezoelectric Motion Controller

MC - NewtonLT.06



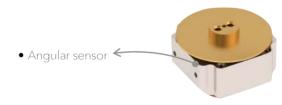
• Sample holder,16 channels (.MF16)



PEEK sample holder



Mechanical base



Rotator.25.SE
 25 mm Piezoelectric rotator
 Multifields Technologies - Piezoelectric Motion

Rotator.25.SE - Specifications

	Temperature: 1.4 ~ 400 K;	5. Driving Voltage	20V ~ 200 V
1. Work environment	Pressure: 1 × 10 ⁻⁷ mbar;	6. Max. Load	100 g
	Max. Field: 35 Tesla	7. Sensor	Resistance sensor
2. Weight	10 g	8. Sensor Range	270°
3. Range	-20° ~ 200°	9. Sensor Precision	0.01°
4. Max. Speed	~ 10 °/s @300 K	10. Repeatability	~ 0.05°

1.3 Dual Axis Rotation - Applications

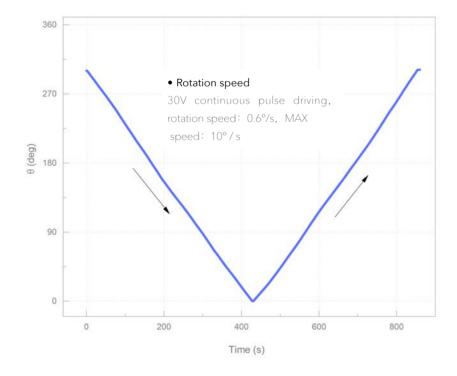
Application (1)-

Rotation in full range

Sample Information | Empty

Multifields Products | 1. ETM.2DRotProbe.50.MF16 | 2. MC - NewtonLT.06

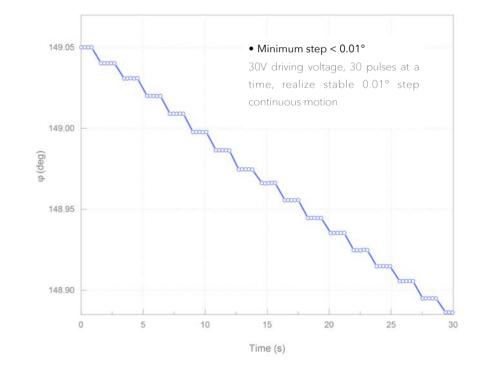
Platform | Oxford TeslatronPT



Application (2)-

Step precision test





1.4 ETM Accessories - Overview

Essential & recommended options for electric transport measurement

Matrix Switch



MF.Matrix.6-24

Breakout Box



MF.BreakoutBox.Pro.Max



MF.CheckStage.PP12.BNC



ETM.BondingCube.PP12



ETM.R-Cube.1-2



Cables

Accessories



Sample Holders

MultiFields

■ Electric Transport Measurement (ETM)

1.4.1 Matrix Switch System

Arbitrarily switch the connection between the source meter and the device to make the measurement as you wish!



MF.Matrix.6-24

Matrix switch system support a wide range of signals in the test and measurements industry. DC switching capabilities from 10 nV to 0.5 kV make MultiFields matrix system a versatile production test tool for a wide array of applications. Touch-screen directly control eliminates the need for the computer to control every step of the test procedure. The status of every channels all shows on screen simultaneously.

Key Features

- ⁻ 6 row BNC connectors; 24 columns Lemo.3B.26pins
- Max. Voltage allowed to use is 250 V
- The line switching time is about 3ms;
- Software supports automatic switching of multiple samples and van de Paul method
- The touch-screen real-time monitors and controls the state of all available channels;
- IEEE-488 & RS232 interface

MF.Matrix.6-24 · Specification

General Information	
Matrix Configuration	6 * 24 each of the 144 cross-points is made up of a relay switch. By closing the appropriate crosspoint switch, any matrix row can be connected to any column in the matrix.
Connectors	6 rows ~ BNC connectors; 24 columns ~ Lemo.3B.26pins;
Size	19 inch rack unit, 2U
Work environment	0 ~ 50 °C;
Technique Details	
Max. DC Voltage	220V DC between any two pins, 2A switched.
Max. AC Voltage	250V AC peak between any two pins, 2A switched.
Common Mode Voltage	175 V Peak
Contact Life	Cold Switching 10 ⁸ times
Channel Resistance	< 1 Omega
Offset Current	< 100pA
Contact Potential	< 500nV
Actuation time	3ms
Isolation	Above 10 ⁹ omega between paths
Crosstalk between Channels	< -35 dB
Relay Drive Current	16 mA
Interface & Communication	
Trigger Sources	RS232 / GPIB / Manual (Touch-Screen)
Communication	GPIB / RS232
Software	Labview VI

■ Electric Transport Measurement (ETM)

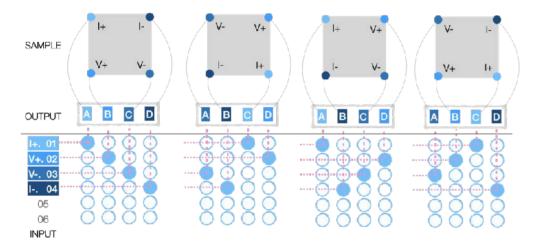
1.4.1 Matrix Switch System - Applications

Arbitrarily switch the connection between the source meter and the device to make the measurement as you wish!

Application (1)-

van de Pauw Method

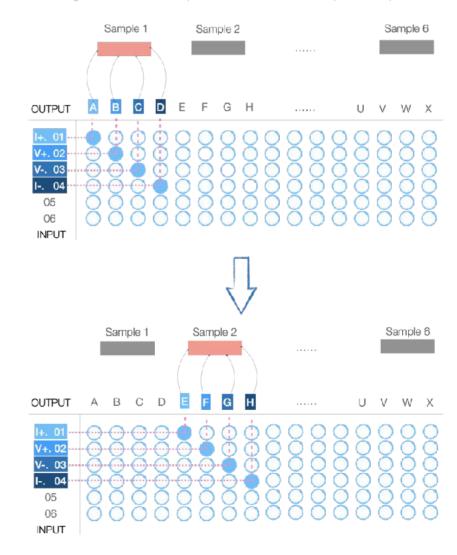
It is a technique commonly used to measure the resistivity and hall coefficient of a homogenous and isotropic sample with arbitrary shape. Using the built -in algorithm, the switch matrix automatically switch current I and voltage V among the four contacts of the sample according to Van De Pauw procedure, and calculate the resistivity or hall coefficient, precisely.



Application (2)-

Multiple sample measurement

To improve efficiency, researchers often use multiple sets of SMU(Source meter unit) to perform high throughout sample measurements, which cannot be afforded by most labs. One set of SMU plus MultiFields switch matrix can perfectly solve this problem at much lower cost: Switch matrix supports automatic switching between different samples and simultaneous test of up to six samples.



■ Electric Transport Measurement (ETM)

1.4.2 Breakout Box with ESD Protection

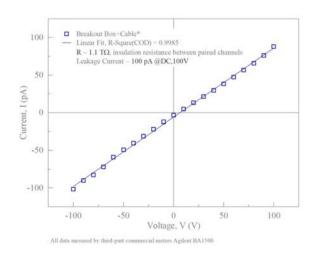
Low leakage current guarantees a higher signal accuracy and better resolution.



MF.BreakoutBox.Pro.Max

Breakout Box is designed to play a role of connector adaptor between sample probe and commercial electric meters. The **leakage current** and pick-up **noise level** are key parameters for a better weak-signal quality. As the research field of low-dimension materials and nano-device raising, **ESD** (**electrostatic discharge**) **protection** becomes indispensable function for a breakout box.

"Breakout Box Pro 24pins" is a perfect solution, whose leakage current and noise level are strictly constrained to a very low level. And it supples a complete ESD protection throughout the sample measurement, (1) sample & meters first connect to systems; (2) sample & meters in standby statues.



Key Feature

- → 3 status prepared for end user's experiments, Float, GND and Measurement
- → Paired with MultiFields original cable(2.5m length) only 100 pA leakage current @ DC-100V voltage
- → Max. Voltage allowed to use is 500 V
- → 12pins & 24pins two versions available



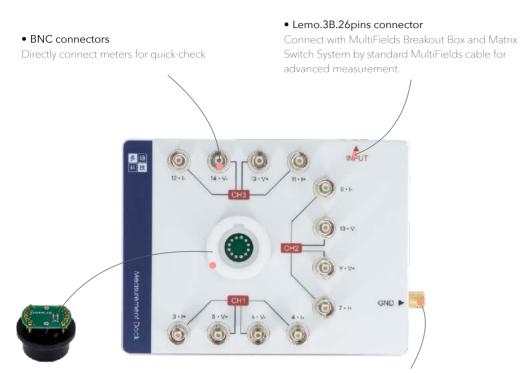




	Breakout Box 24pins MF.BreakoutBox.Max	Breakout Box ^{Pro} 12pins MF.BreakoutBox.Pro	Breakout Box 24pins MF.BreakoutBox			
Advanced Function	Low noise Low leakage current	Low noise Low leakage current ESD protection	Low noise Low leakage current			
Output channels	24 channels	12 channels	12 channels			
Installation		19-inch Rack Size				
Hight	2U	1U	1U			
Input	Lemo.3B.26pin					
Output	Standard BNC					
Leakage current	100 pA@ DC 100V					
Shield & GND	All BNC connectors' shield and metal box are electric-connected. One individual banana connector is left to end user, connecting to GND or keeping it float.					

1.4.3 Check Stage

Flexible desktop breakout box for device measurements anytime & anywhere



• Removable Holder Base

Holder base can be flexibly adapted to a variety of sample holders

• Banana (F) Connector

BNC shields and the box's metal housing are electric-connected with this connector.

MF.CheckStage.PP12.BNC

Compatible with all sample holder MultiFields supplied in various measurement solution.

- Electric transport
- Thermal transport
- Dielectric & Ferroelectric

-









	Sample Holder - 8pin	Sample Holder - 12pin	Sample Holder - 16pin
	MF.CheckStage.MF8.BNC	MF.CheckStage.MF12.BNC	MF.CheckStage.MF16.BNC
Advanced Function	Low noise Low leakage current	Low noise Low leakage current ESD protection	Low noise Low leakage current
Channel	8 channels	12 channels	16 channels
		ETM.SH.MF12.OP	ETM.SH.MF16.OP
适配样品托	ETM.SH.MF8.OP	ETM.SH.MF12.OP.Cu	ETM.SH.MF16.OP.Cu
		ETM.SH.MF12.IP	ETM.SH.MF16.IP
Input	Lemo.3B.14pin	Lemo.3B.14pin	Lemo.3B.26pin
Output		Standard BNC	
Leakage current		100 pA@ DC 100V	
Shield & GND		and metal box are electric-conne to end user, connecting to GND	

www.multi-field.com | MultiFields Technologies

■ Electric Transport Measurement (ETM)

1.4.4 ETM Accessories

Options for Electric Transport Measurement



ETM.BongdingCube.PP12

Bonding Cube series

- ETM.BongdingCube.PP12
- ETM.BongdingCube.MF8
- ETM.BongdingCube.MF12
- ETM.BongdingCube.MF16
- •

BondingCube (Wire-bonding ESD protection cube) →

Wire bonding is the process of creating electric connection between sample and sample-holder using bonding wires, such as aluminum and gold. For many low-dimension or nano-device, the ESD protection is very important during sample transferring and bonding process.

All the sample holder's pins are electric-connected with the whole bulk copper cube and one banana(f) connector left for linking to GND.



ETM.R-Cube.1-2

R - Cube →

A resistor with switchable resistance values, providing a 5-position switch for switching between 5 different resistances. "1 - 2" for splitting the core and shell of one BNC connector to two BNC connectors while connecting the resistor; "1 to 1" for connecting the resistor directly between two cores BNC connectors.

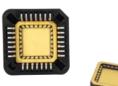
Mary Jan

ETM.SH.MF12.OP



ETM.SH.MF12.IP









ETM Sample Holder series

MultiFields

&Group

- ETM.SH.MF8.OP
- ETM.SH.PP12.OP
- ETM.SH.PP12.OP.Cu
- ETM.SH.PP12.IP
- ETM.SH.MF12.OP
- ETM.SH.MF12.OP.Cu
- ETM.SH.MF12.IP
- ETM.SH.MF16.OP
- ETM.SH.MF16.OP.Cu
- ETM.SH.MF16.IP
- ETM.SH.MF24.OP
- ETM.SH.MF24.OP.Cu
- ETM.SH.MF24.IP
- ETM.SH.DIP8m
- ETM.SH.DIP8
- ETM.SH.DIP16m
- ETM.SH.DIP16
- ETM.SH.DIP24
- ETM.SH.LCC20
- ETM.SH.LCC24
- ETM.SH.LCC28
- ETM.SH.LCC44

•

Sample Holder-

ETM.SH.MF12.OP.Cu

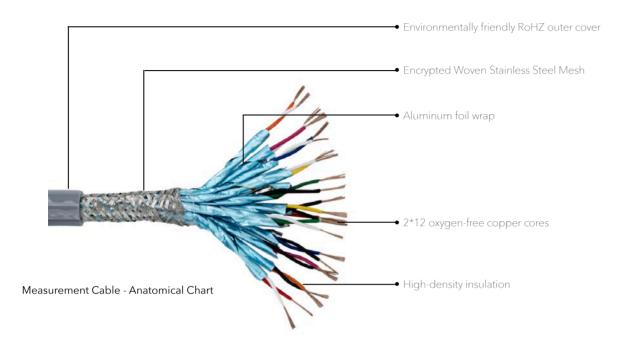
A variety of sample holders, including MF standard 12pins/16pins/24pins PCB sample holders, LCC / DIP ceramic sample holders, and customized sample holders.



■ Electric Transport Measurement (ETM)

1.4.4 ETM Accessories - Cables

Options for Electric Transport Measurement





ETM.Cable.HC19-Lemo26

Measurement Cable →

Multifields Technologies provides high-quality twisted shielded cables, coaxial cables, etc. as measurement cables. Connectors can be adapted to mil-spec connectors, LEMO, Fischer and other connectors as required.

→Recommend Models:

- ETM.Cable.HC19-Lemo26
- ETM.Cable.HC26-Lemo26
- ETM.Cable.HC19-Lemo14
- ETM.Cable.HC26-Lemo14

- ETM.Cable.Lemo14-Lemo26
- ETM.Cable.Lemo14-Lemo26
- ETM.Cable.Fischer16-Lemo26
- ETM.Cable.Fischer24-Lemo26

•

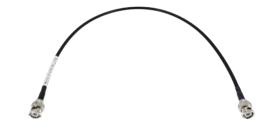


Instrumentation Cables→

Multifields Technologies provides cables for a variety of electrical source meters, such as Keithley 2400/6221/2182A/6517B/4200, etc., SRS SR830/850/860, etc., and Keysight 4980A(L)/3446x, etc. The professional modifications and upgrades make the cables more convenient and flexible to use.

⇒Recommend Models:

- ETM.Cable.6221M
- ETM.Cable.6221T
- ETM.Cable.2182M
- ETM.Cable.2BNC
- ETM.Cable.BNC-SMA
- ETM.Cable.2Ban-BNC
- ETM.Cable.Cryo.SS
- ETM.Cable.Cryo.SC
-







Thermal Measurements · Series









Thermal Transport Measurement (TTM)

Thermal conductivity and thermoelectric effect

Thermal Transport Measurement (TTM)

Thermoelectric potential

Heat Capacity Measurement (HCM)

Excellent adiabatic control and accurate

Thermal Expansion Measurement (ThE)

Sensing small displacement with temperature/field

Functions		ty and thermoelectric effect bulk materials	for thin-film materials	measurement of the heat capacity	Sensing small displacement with temperature/field using a parallel plates capacitor
1 Work environment			·Temperature: 1.4 K \sim 400 K; Pressure: $10^5 \sim 10^{-5}$ Pa; Magnetic Field: $0 \sim 18$ Te		Tesla;
2 Diameter				dia-26 mm / dia-30 mm / dia-50 mm	
3 Sample Types	Bulk		Thin Film	Bulk	Bulk
4 Functions	Thermal conductivity	Seebeck effect, Nernst effect, Peltier effect	Seebeck effect, Nernst effect,	Heat capacity measurement	Thermal expansion / magnetostriction effect
5 Sample Requirements	Size < 3 mm *	3 mm * 10 mm (bulk)	Size < 5 mm * 8 mm (thin film)	Size < 3 mm * 3 mm * 5 mm; Weight 1 ~ 300 mg	Thickness: 0.1 ∼ 6 mm
6 Meas. Range	Conductivity: 10 µW/K ~ 100 mW/K	Seebeck coefficient: 0.1 µV/K ~ 1 V/K*	Seebeck coefficient: 0.1 μV/K ~ 1 V/K*	Heat capacity:	expansion and contraction: ΔL : -0.1 ~ 0.1mm
7 Accuracy	± 5%	5, 1.5 ~ 400 K	± 5%, 1.5 ~ 400 K	± 5%, 1.5 ~ 400 K	
8 Resolution	Conductivity: 1 μW/K	Thermal voltage: 2 nV (Minimum range)	Thermal voltage: 2 nV (Minimum range)	10 nJ @ 2K	50 pm for AH Series and 0.5 nm for Keysight Series

^{*} Measurement range of Seebeck coefficient depends on the measurement temperature;

^{*} The Multifields Technologies thermal measurements series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others;

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.



2. Thermal Transport Measurement (TTM)

An integrated solution for thermal conductivity, Seebeck and resistance measurement

Thermal Transport Measurement Systems, Delivery List

TTM Meter (§ 2.1) TTM.Meter.Basic; TTM.Meter.NanoV-01/02



TTM Probe (§ 2.2) TTM.Probe.26P; TTM.Probe.30.In 2 TTM.Probe.30.Cone; TTM.Probe.50.In TTM.Probe.50.Cone



TTM Accessories (§ 2.3) 3 TTM.Toolbox; TTM.SH.Bulk; TTM.SH.Film;



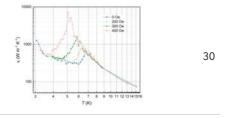
27

29

TTM Measurement Software (§ 2.4) AutoLab.TTM



TTM Applications (§ 2.5)



MultiFields &Group

Thermal Transport Measurement Systems - Specification

Work Environment		
Work Environment	Temperature: 1.5	~ 400 K; Field: 0~18 Tesla
Compatible Platforms	Oxford TeslatronF	PT, PPMS, Cryogenics, etc
TM System Performance		
Sample Types	Bull	k & thin film*
	Accuracy	± 5%, 1.5 ~ 400 K
Thermal Conductivity	Range	10 μW/K ~ 100 mW/K
	Accuracy	±5% or ± 100 nV
Seebeck Coefficient	Range	0.1 μV/K ~ 1 V/K**
Sample Size (Recommend) TTM Meter	- 2.5*1.5*6 mm³ for 0.1 - 1.5*1.5*6 mm³ for 2 ~ - 1.5*1.5*10 mm³ for >3	50 W/m·K
Functions	 2-channel thermocoup 1-channel heater outp 2-channel temperature 1-channel nano-volt m 	ut e monitoring
Size	280 mm * 220	mm * 88 mm (W*H*L)
Interfaces	U	SB & GPIB
TTM Software		
Environment Control	Temperature, magi	netic field, state of chamber
Measurements		eck effect, Nernst effect, Peltier effect Id thermal Hall effect
Automatic Function	Auto-tuning of Δ T at different	temperatures avoiding radiation los

^{*} Details will be discussed in next section;

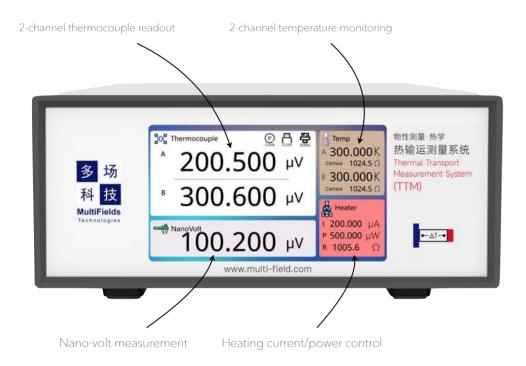
^{**} Measurement range of Seebeck coefficient depends on the sample temperature;

^{***} Nano-volt module.

■ Thermal Transport Teasurement Systems (TTM)

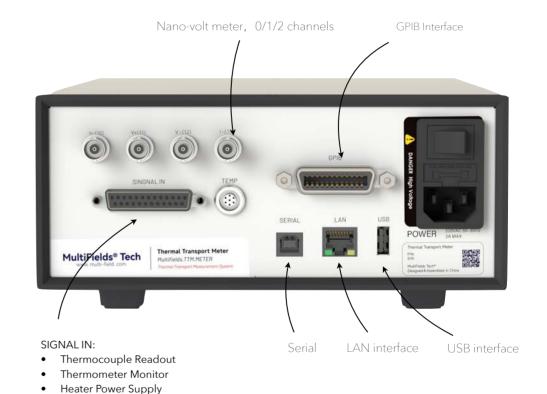
2.1 TTM Meter

Built-in thermocouple and thermometer monitoring module for precise control of thermal gradients. Optional multiple nanovolt measurement channels



Key Features

- High precision steady-state measurement method makes batter than 5% accuracy for thermal conductivity and Seebeck susceptibility
- Built-in automatic iterative algorithm for optimal deltaT selection at different temperature
- Specialized measuring meter enables one-stop high precision measurement
- Supporting bulk thermal transport measurement and thin film thermoelectric coefficient by switching to different measurement modules
- Available from 1.5 to 400 K and up to 18 Tesla magnetic field
- Compatible with Oxford® TeslatronPT, QD® PPMS, Cryogenics® and other third-party systems



TTM. Meter.Basic
TTM.Meter.NanoV01 / 02 / 03

2.1 TTM Meter

TTM Meter - Sepecifications

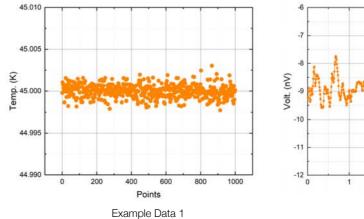
Funtion.01	Thermocou	uple Readout	
Channel	2		
Range	±2 mV		
Resolution (RMS)	30) nV	
Rate	10:	SPS*	
Thermalcouple	S/K/E/J	J/T/AuFe	
Funtion.02	Thermocou	ıple Readout	
Channel		1	
Range	0~10 mA (Current)	0~100 mW (Power)	
Heater Resistance	1 k(Ohm	
Accuracy	<0.1 % (Power)	1 uV (Voltage)	
Rate	10	SPS	
Funtion.03	Temperat	ure Sensor	
Channel		2	
Sensor Types	Cernox™ & PT100	& PT1000 & Diodes	
Measurement Range	0.3 ~ 420 K (Ce	ernox TM CX-1030)	
Auto Range	Y	ES	
Reverse Current	Y	ES	
Curves	300 points. Max. 100 curves		
Filters	Kalman Filter		
Resolution (see example data 1)	0.0	0.001%	

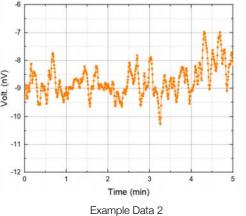
^{*} SPS: Sample per second

Funtion.04		Nanovolt Meter	
Channel		1	
Range		±2 V	
	Input Range	Gain	Resolution (RMS)
	± 2 μV	1 M	2 nV

	Input Range	Gain	Resolution (RMS)
	± 2 μV	1 M	2 nV
	± 20 μV	100 k	2 nV
Resolution (RMS)	± 200 μV	10 k	2 nV
(see example data 2)	± 2 mV	1 k	20 nV
	± 20 mV	128	50 nV
	± 200 mV	8	200 nV
	± 2 V	1	2 uV
Rate		10 SPS	
Input Resistance	> 1 GOhm		

Funtion.05	Communication & Connectors
Communacation	GPIB & USB
Display	5.0 inch TFT touch-screen with 1280 x 720 pixels
Power	220 VAC, 1 Amp MAX



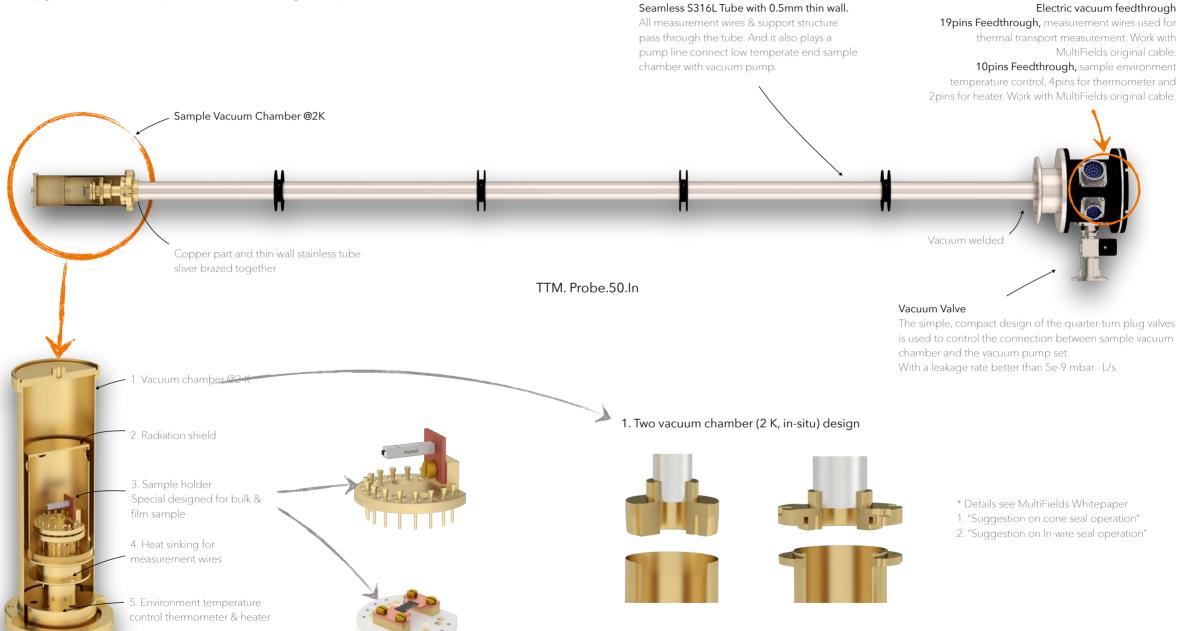


MultiFields

■ Thermal Transport Measurement Systems (TTM)

2.2 TTM Probes

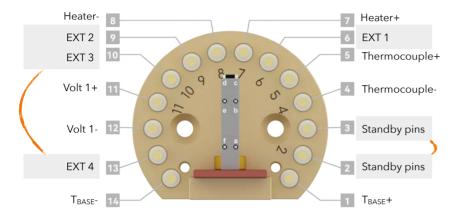
The TTM probe with a 2 Kelvin in-situ vacuum chamber guarantees no heat leakage caused by gas flow around sample. Two different design sample holder.



■ Thermal transport measurement Systems (TTM)

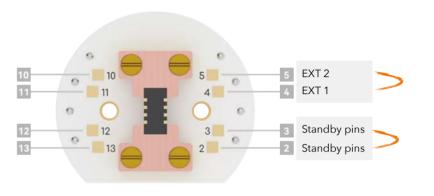
2.3 TTM Accessories - Sample holder

For bulk/film sample MultiFields® supplied two sample holder design.



Bulk sample holder TTM. SH.Bulk

	Pin function	Specification	Pin Number	Note
Fun	ction pins			
1	Termometer 1	Cernox [™] thermometer, monitor base temperature	1 & 14	Paired
2	Termalcouple	Measure temperature difference, Δ T	4 & 5	Paired
3	Heater	1k~10k Ohm heater, voltage and current are measured simultaneously to accurately obtain heating power	7 & 8	Paired
4	Thermal Votage	Used to measure thermopower voltage. Pure copper wire guarantees lower voltage offset.	11 & 12	Paired
Star	ndby pins			
5	Standby pins	Pure copper wire. Suggest used for low voltage signal measurement. One pair independent connectors at probe	2 & 3	Paired
6	EXT 1, 2	Spare for customer use, BNC connectors on MultiFields TTM meter	6 & 9	Paired
7	EXT 3, 4	Spare for customer use. Recommend: Current source for R measurement. BNC connectors on MultiFields TTM meter	10 & 13	Paired



Thin-film sample holder TTM. SH.Film

	Pin function	Specification	Pin Number	Note
Fund	ction pins			
1	Thermometer 1	Cernox [™] thermometer, monitor base temperature	1 & 14	Paired
2	Thermometer 2	Cernox™ thermometer, monitor high-T end	6 & 9	Paired
3	Heater	1 k~10 k Ohm heater, voltage and current are measured simultaneously to accurately obtain heating power	7 & 8	Paired
4	Thermopower voltage	Used to measure thermopower voltage. Pure copper wires guarantees lower voltage offset.	11 & 12	Paired
Stan	ndby pins			
5	Standby pins	Pure copper wire. Suggest used for low voltage signal measurement. One pair independent connectors at probe	2 & 3	Paired
6	EXT 1, 2	Spare for customer use	4 & 5	Paired
7	EXT 3, 4	Spare for customer use. Recommend: Current source for R measurement. BNC connectors on MultiFields TTM meter	10 & 13	Paired

■ Thermal Transport Measurement Systems (TTM)

2.3 TTM Accessories - ToolBox

Thermal transport measurements require skilled operation and wellprepared experimental accessories for higher accuracy



TTM. Toolbox

MultiFields & Group

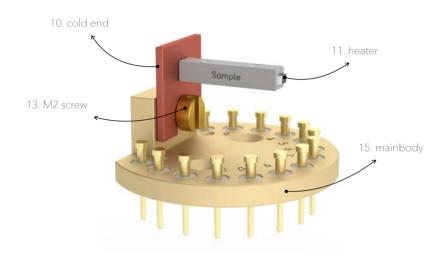
ToolBox List

items		Specification	Quantity
Star	ndard Sample		
1	Pb 4N	Pb metal wire, 99.99%, Φ 2.0 mm, Length 2 cm Alfa	1 pc
2	Fused Quartz	Quartz cubic block, 99.99% 3 mm x 3 mm x 2mm	10 pcs
Adł	nesive		
3	N-Grease		
4 -	Adhesive-Black Part A	Electric insulted, good thermal conductivity at 2K, epoxy.	5 g
4	Adhesive-Black Part B	Electric insulted, good thermal conductivity at 2K, catalyst.	5 g
5 -	Adhesive-Sliver Part A	Good electric conductivity , good thermal conductivity at 2K, epoxy.	5 g
5 -	Adhesive-Sliver Part B	Good electric conductivity , good thermal conductivity at 2K, catalyst.	5 g
The	rmocouples wires		
6 -	Thermocouple 1 Part A	E-Type thermocouple, Chromel wire, Φ25 μm	1 m
0 -	Thermocouple 1 Part B	E-Type thermocouple, Constantan wire, Φ 25 μ m	1 m
7 -	Thermocouple 2 Part A	Chromel wire, Φ25 μm	1 m
7 -	Thermocouple 2 Part B	AuFe wires, Φ25 μm	10 cm
Aux	iliary		
8	Tweezer	Non-magnetic, 140 mm (length)	1 pc
9	Syringe		

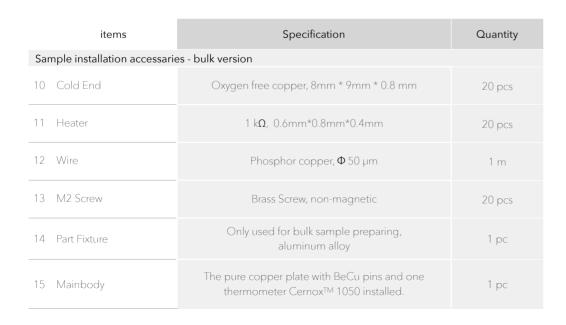
■ Thermal Transport Measurement Systems (TTM)

2.3 TTM Accessories - ToolBox

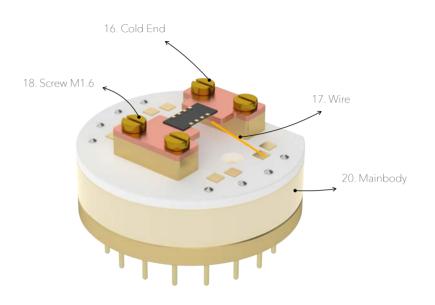
The toolbox is designed for bulk and film samples with matching accessories.



TTM. SH.Bulk



MultiFields & Group



TTM. SH.Film

items	Specification	Quantity
Sample installation accessaries	s - film version	
16 Cold End	Oxygen free copper, mm * mm * mm	20 pcs
17 Wire	1 kΩ, 1m*1m*05mm	1 m
18 M1.6 Screw	Brass Screw, non-magnetic	20 pcs
19 Part Fixture	Only used for film sample preparing, aluminum alloy	1 pc
20 Mainbody	The pure copper plate with BeCu pins and one thermometer Cernox™ 1050 installed.	1 pc

MultiFields

&Group

2.4 TTM Software

The measurement and system data is shown here in real time.

Setting Zone

The platform, sample information, instrument selection can be setting in this zone.

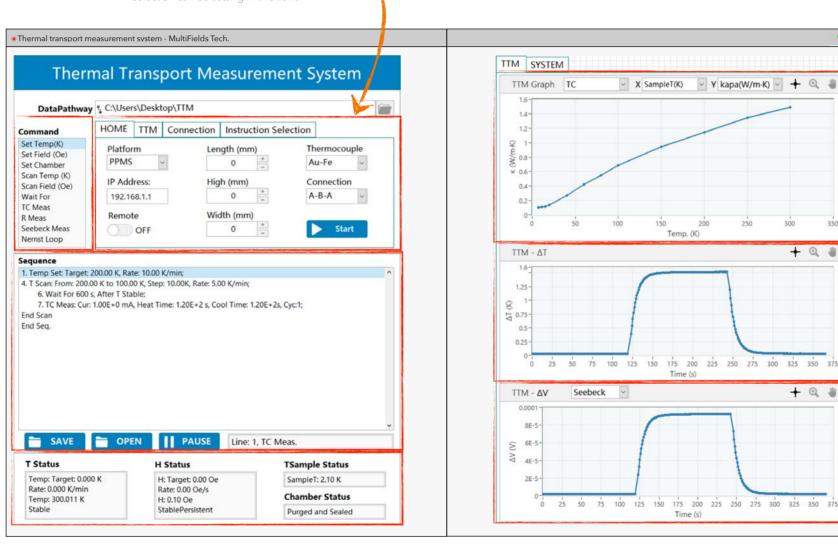
 Measurement command All measurement commands are listed, including temperature and field settings, TTM commands. The arrangement of these commands allows for automated measurements.

•Sequence list

The command list is shown in this section. You can modify or delete one of them. Besides, the command list can be save or open. The sequence status is shown in the status bar.

System Status

The temperature, field and chamber status can be display and modified quickly.



•Measurement Result

...

+ 0, 4

+ 0 4

∨ Y kapa(W/m·K) ∨ + ⊕

■

The TTM results will be shown in this figure. We can plot the figure with different X axis and Y axis.

•TTM - ΔT Curve

The temperature vs. time curve will be plot in this figure in real time.

●TTM - ΔV Curve

The voltage change will be plotted in this figure. The x-axis can be time or magnetic field when Seebeck or Nernst susceptibility is measured.

2.5 TTM - Applications

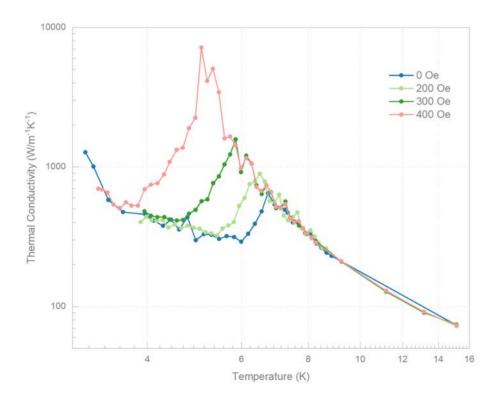
Application (1)-

Thermal conductivity behavior during superconducting transitions of Pb

Sample Information pure Pb / 99.99% , Alfa

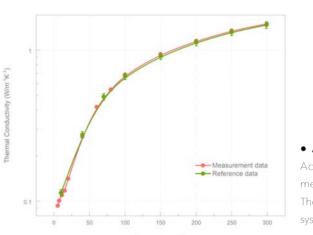
MultiFields Products 1. TTM.Meter 2. TTM.Probe

Electric Meters Oxford TeslatronPT



Application (2)-

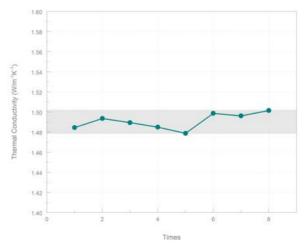
Thermal conductivity of fused quartz rods





• Accuracy < 5%

Accuracy refers to the deviation of the measurement result from the "true value". Thermal conductivities obtained from MF TTM system are accurate to within 5%, comparing the measured value with a reference value of the standard sample.



• Repeatability < 2%

Repeatability is the deviation between multiple measurements. By repeating the thermal conductivity measurement several times under the same conditions, the repeatability of the thermal conductivity measurement of MF TTM system was obtained to be within 2%.

2.5 TTM - Applications

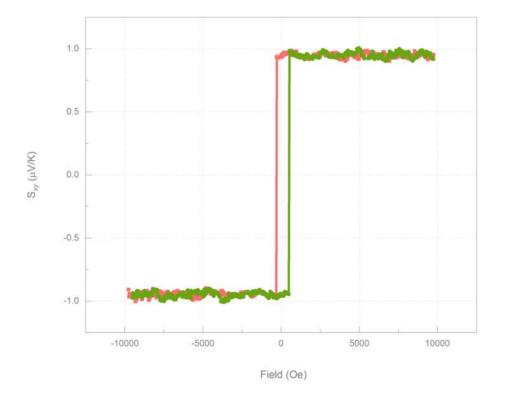
Application (3)-

Anomalous Nernst effect in magnetic Wyel semimetals

Sample Information magnetic Wyel semimetals

MultiFields Products 1. TTM Systems, meter 2. TTM Systems, probe

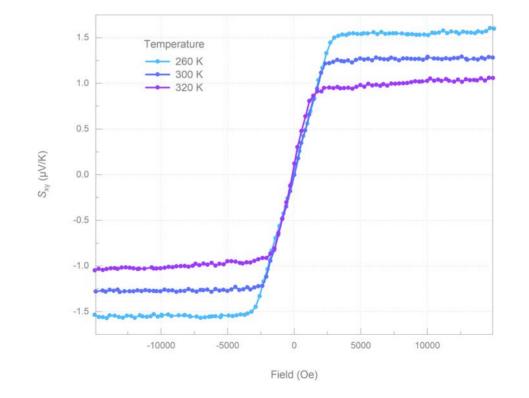
Electric Meters Oxford TeslatronPT



Application (4)-

Anomalous Nernst effect in the non-collinear antiferromagneticmaterial NdMn₂Ge₂







Thermal Measurements

3. Heat Capacity Measurement (HCM)

Integrated solutions for specific heat capacity measurement

Heat Capacitance Measurement (HCM), Delivery List

HCM Meter (§ 3.1)
HCM.Meter



HCM Probe (§ 3.2)

HCM.Probe.26P; HCM.Probe.30.In

HCM.Probe.30.Cone; HCM.Probe.50.In

HCM.Probe.50.Cone



3 HCM Accessories (§ 3.3)
HCM.Toolbox; HCM.SH

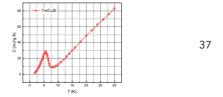


4 HCM Software (§ 3.4)

AutoLab.HCM



5 HCM Applications (§ 3.5)



MultiFields & Group

Heat Capacitance Measurement (HCM) - Specification

Work Environment	
Work environment	Temperature: 1.5 ~ 400 K; Field: 0~18 Tesla
Compatible Platforms	Oxford TeslatronPT, PPMS, Cryogenics, etc
HCM System Performance	
Sample Weight	1 mg ∼ 500 mg
Accuracy	5% error @ 1.5 ~400 K
Resolution	10 nJ @ 2K
Max Sample Size	3 * 3 mm²
Fitting Model	1-т & 2-т
HCM Meter	
Function	 1-channel heater output 2-channel temperature monitoring Built-in heat capacity measurement processes; Auto fitting
Size	280 mm * 220 mm * 88 mm (W * H * L)
Interface	USB & GPIB
Software	
Environment Control	Temperature, magnetic field, state of chamber
Measurements	Heat capacity vs. Magnetic Field / Temperature
Automatic Function	Thermal relaxation method for measuring heat capacity; Built-in 1-T & 2-T models

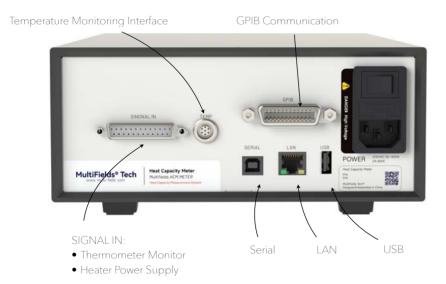
36

3.1 HCM Meter

Built-in heating and high-speed temperature monitoring channels, collecting temperature changes for real-time fitting



The optimal heating time can be calculated automatically based on the measurement results, making the measurement results more reliable.



Key Features

- Highly accurate heat capacity measurements based on thermal relaxation methods;
- Integrated low-temperature specific heat capacity measurement solution, including: HCM Meter, probe, automatic data acquisition, and algorithms;
- Compatible with Oxford® TeslatronPT, QD® PPMS, Cryogenics® and other third-party systems



Heat Capacitance Measurement System - Specification

Function.01	Temperature r	nonitor
Channel	2	
Sensor Type	Cernox™ & PT100 & P	T1000 & Diode
Range	0.3 ~ 420 K (Cerno»	(TM CX-1030)
AutoRange	YES	
Current Reverse	YES	
Calibration Curve	300 Points and 100	Curves MAX
Resolution	0.001%	
Funtion.02	Heater modular	
Channel	1	
Range	0~10 mA (Current)	0~100 mW (Power)
Heater Resistance	1 kOhm	1
Accuracy	<0.1 % (Power)	1 uV (Voltage)
Rate	10 SPS	
Funtion.03	Communication & Connector	
Electric Connetor	D-Sub 25	
Communacation	GPIB & USB	
Display	5.0 inch TFT touch-screen with 1280 x 720 pixels	
Power	220 VAC, 1 Amp MAX	

^{*} SPS: Sample per second

MultiFields

Electric vacuum feedthrough

MultiFields original cable.

19pins Feedthrough, measurement wires used for

thermal transport measurement. Work with

&Group

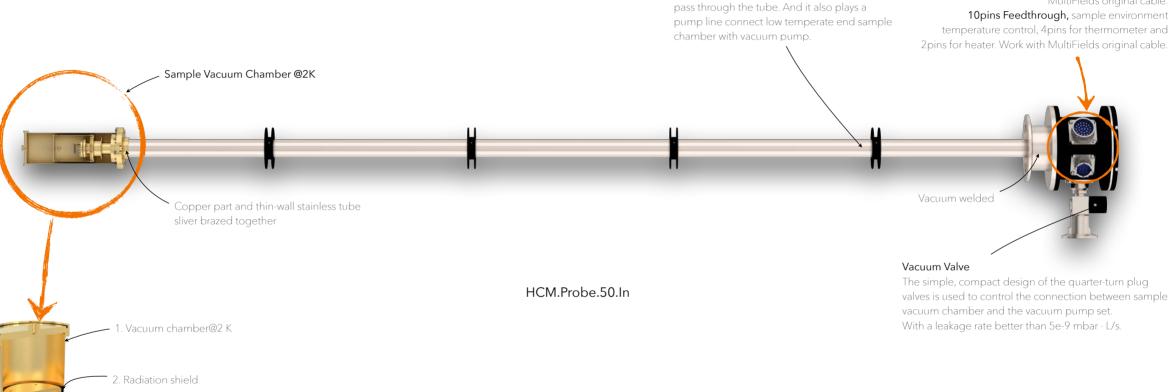
3.2 HCM Probe

The HCM probe with a 2 Kelvin in-situ vacuum chamber guarantees no heat leakage caused by gas flow around sample.

3. Sample holder

4. Heat sinking for measurement wires

5. Environment temperature control thermometer & heater



1. Two vacuum chamber (2 K, in-situ) design

Seamless S316L Tube with 0.5mm thin wall.

All measurement wires & support structure

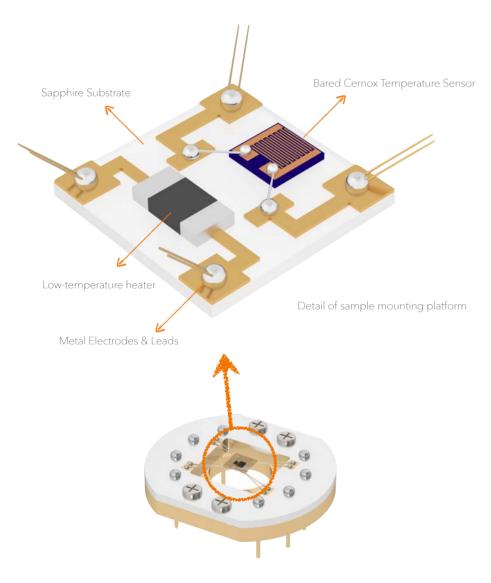


- *Details see MultiFields® whitepaper
- 1. "Suggestion on cone seal operation"
- 2. "Suggestion on In-wire seal operation"

→ HCM.SampleHolder

3.3 HCM Accessories

Specific heat capacity measurement is made easy with specialized mounting tools and accessories.



HCM Sample Holder HCM.SH





HCM. Toolbox

	items	Specification	Quantity
Standard Sample			
1	Pure Pb	Pb rod, purity 99.99%, Φ2.0 mm, Length 2 cm Alfa	1 pc
Ac	lhesives		
2	N-Grease	Thermally conductive grease	5 g
3	H-Grease	Vacuum Grease	5 g
4	GE-Vanish	Low-temperature adhesive	5 g
То	Tools		
5	HCM Sample Holder	For specific heat capacity measurements	1 pc
6	Sample Holder Fixture	For mounting samples	1 pc
5	Tweezer	Non-magnetic tweezer, 140 mm	1 pc
7	Screws		1 pc
8	Scalpel		1 pc

MultiFields

&Group

3.4 HCM Software

Automation software controlled by computer. compatible with a variety of low-temperature superconducting third-part commercial platforms

Setting Zone

The platform, sample information, instrument selection can be setting in this zone.

• Measurement command

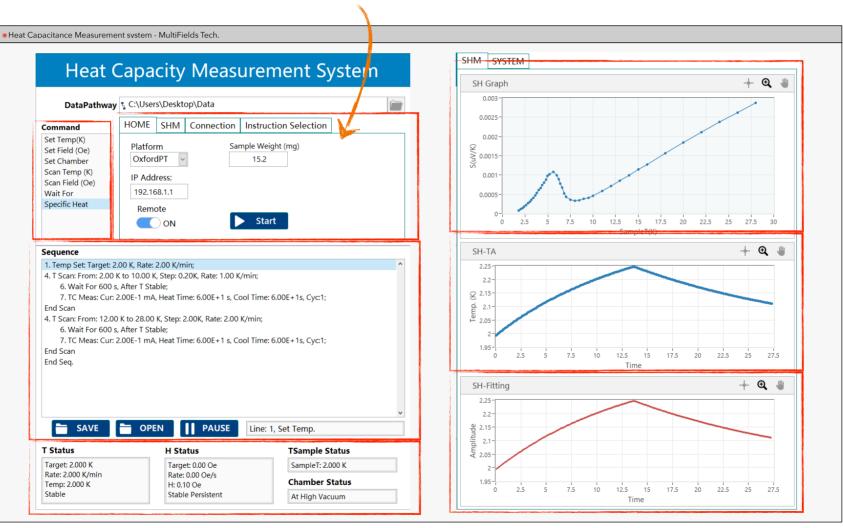
All measurement commands are listed, including temperature and field settings, HCM commands. The arrangement of these commands allows for automated measurements.

• Sequence list

The command list is shown in this section. You can modify or delete one of them. Besides, the command list can be save or open. The sequence status is shown in the status bar.

System Status

The temperature, field and chamber status can be display and modified quickly.



• Measurement Result

The HCM results will be shown in this figure. We can plot the figure with different x and y axis.

• HCM - T vs time Curve (real-time)

The temperature vs. time curve will be plot in this figure in real time.

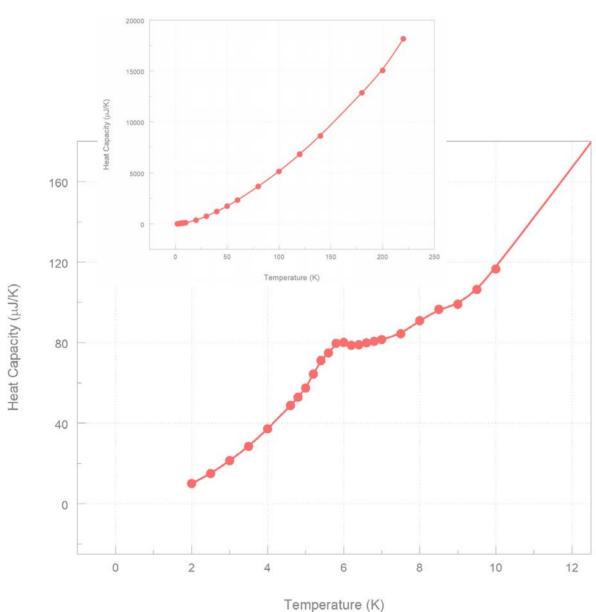
• HCM - Fitting Curve

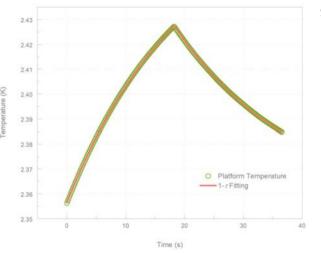
After one complete measurement, the experiment data curve will be fit here by relaxation model of heat capacity. One curve fit out one heat capacity data which is presented in the top figure.

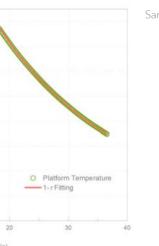
3.5 HCM - Applications

Application (1)-

Heat Capacity Behavior of TmCuSi Phase Transition



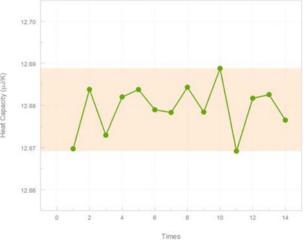






MultiFields 1. HCM.Meter 2. HCM.Probe

Electric Meters QD-PPMS



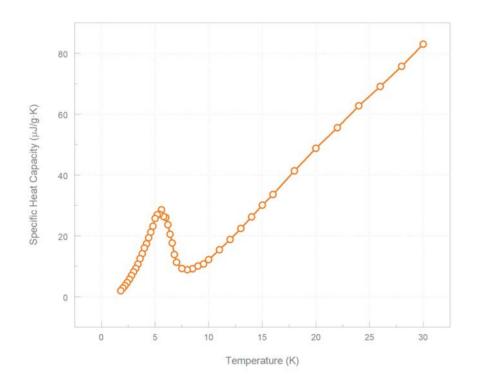
• Repeatability < 20 nJ/K

Repeatability is the deviation between multiple measurements. By repeating the thermal conductivity measurement several times under the same conditions, the repeatability of the thermal conductivity measurement of MF TTM system was obtained to be within 20 nJ/K.

Application (2)-

Specific heat capacity behavior during magnetic entropy transition of TmCuSi

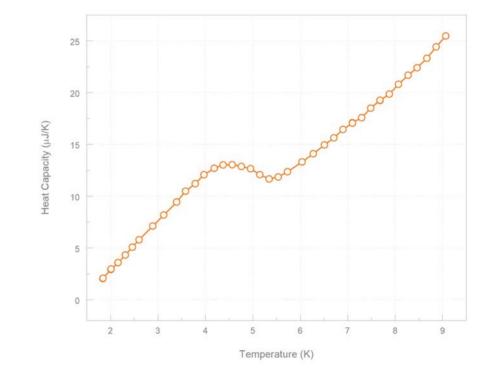




Application (3)-

Specific heat capacity behavior of superconductor during phase transition





Thermal Measurements

4. Thermal Expansion Measurement (ThE)

Integrated solution for thermal expansion measurement

Thermal Expansion Measurement (ThE), Delivery List

Striction Cell (§ 4.1)

ThE.Probe.26P; ThE.Probe.50

ThE.RotProbe.50

ThE.RotProbe.PE.50



41

ThE Accessories (§ 4.2)

ThE Toolbox



42

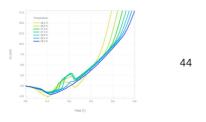
ThE Software (§ 4.3)

AutoLab.ThE



43

4 ThE - Applications (§ 4.4)





Thermal Expansion Measurement (ThE) - Specifications

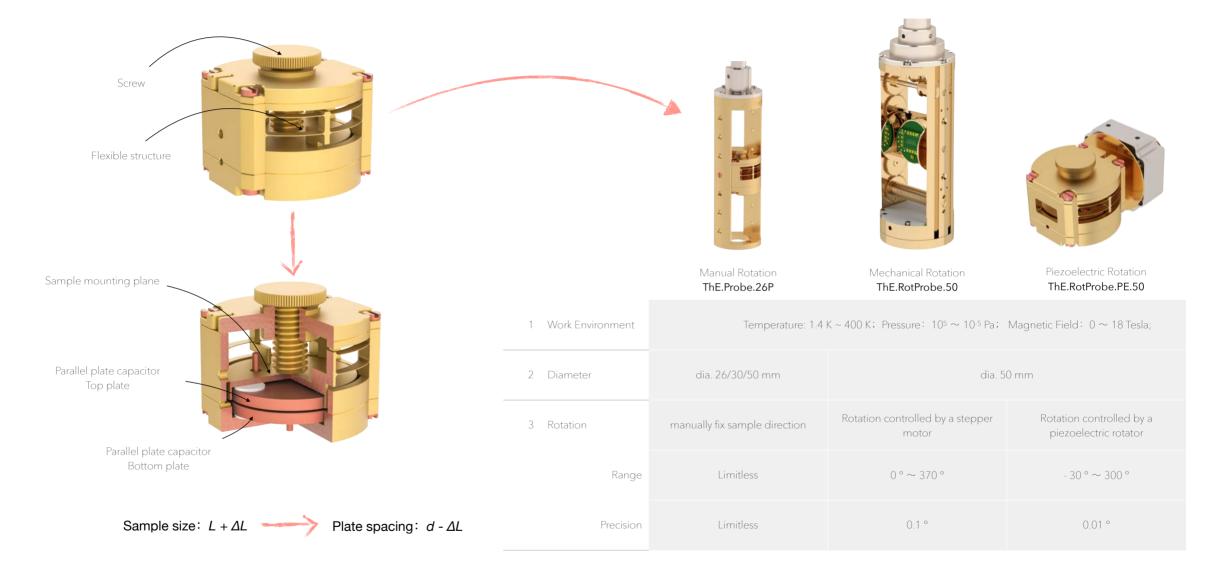
Work Environment

Work environment	Temperature: 1.5 ~ 400 K; Field: 0~18 Tesla
Compatible Platforms	Oxford TeslatronPT, PPMS, Cryogenics, etc
Specifications	
Function	Expansion (Δ L vs T) & magnetostriction (Δ L vs H)
Sample Size	Thickness <i>L</i> ∶ 0.1 mm ∼ 6 mm
Method	Highly precise capacitive position sensing
Resolution	0.05 nm (AH Series capacitance bridge) 0.5 nm (Keysight Series LCR Meter)
Measurement Range	∆ L: -0.1 ~ 0.1mm
Direction of Field	H // ∆ L and H ⊥∆ L
Background Deduction	Based on data of oxygen-free copper standard samples
Sample Mounting	Mechanical fixing, adhesive-free
Options	Electrostriction cell

■ Thermal Expansion Measurement (ThE)

4.1 Striction Cell

Highly precise capacitive position sensor monitors sample size variation



• Measurement Method

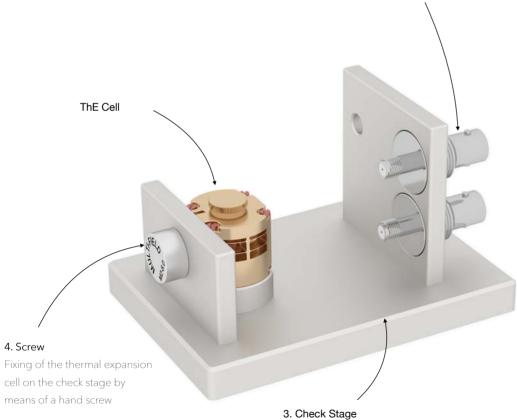
A variation in the sample size L causes a change in the position of the top plate and a consequent change in the plate spacing d. The capacitance between the two plates is monitored to reflect this variation.

4.2 ThE Accessories

Dedicated room temperature installation & calibration tool

Coaxial Connector (SMA - BNC)

The coaxial cable of the cell is connected to the SMA connector and the other end is connected to an LCR meter or capacitance bridge via a cable with a BNC connector, which allows measuring the capacitance of the cell on your desktop, and tune the preload for mounting the sample.



A stainless steel stage for stable placement on a tabletop for the cell testing.

The Accessories List

items	Specification	quantity
Standard Sample		
1 Pure Cu Rod	Cu rod, purity 99.99%, Φ3.12 mm, Length 1, 2, 3 mm Alfa	1
2 Pure Al Rod	Al rod, purity 99.99%, Φ3.12 mm, Length 1, 2, 3 mm Alfa	1
Checking Tools		
3 Check Stage	For tuning the preload of the ThE cell	1
4 Screw	For fixing the ThE cell	1
5 Coaxial Cable	For the capacitance measurement	2
Installation Tools		
5 Wrench	For installing/removing SMA connectors	1
6 Tweezer	Non-magnetic tweezer, 140 mm (length)	1

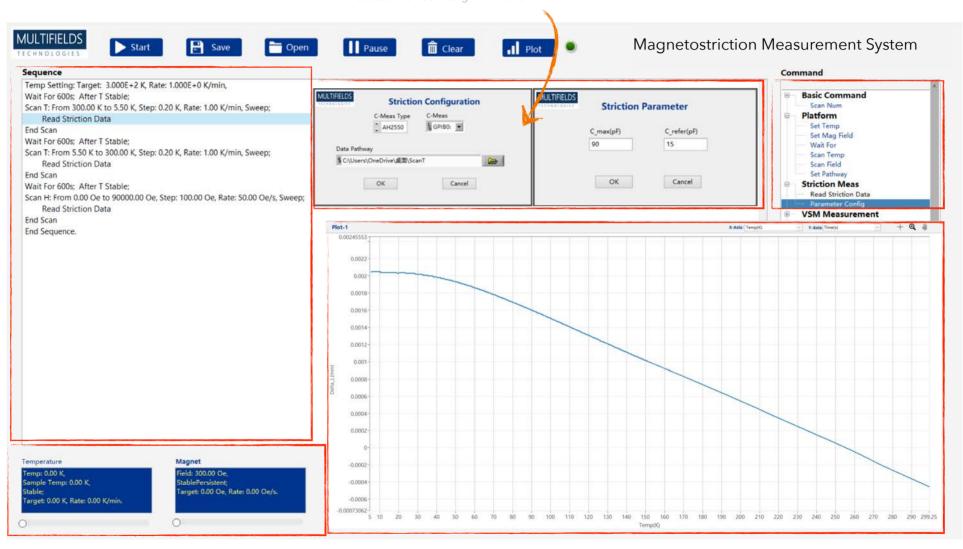
■ Thermal Expansion Measurement (ThE)

4.3 ThE Software

Automation software controlled by computer. compatible with a variety of low-temperature superconducting third-part commercial platforms

Setting Zone

The platform, sample information, instrument selection can be setting in this zone.



• Measurement Result

The results of displacement vs. temperature will be shown in this figure. We can plot the figure with different x and y axis.

• Measurement command All measurement commands are listed, including temperature and field settings, capacitance measurement commands. The arrangement of these commands allows for automated measurements.

MultiFields

&Group

• Sequence list

• System Status

The temperature, field and

and modified quickly.

chamber status can be display

The command list is shown in this section. You can modify or delete one of them. Besides, the command list can be save or open. The sequence status

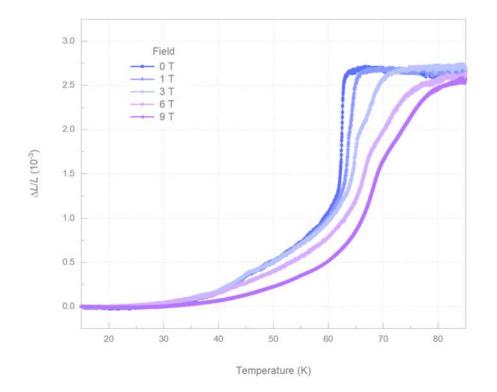
is shown in the status bar.

4.4 ThE - Applications

Application (1)-

Thermal expansion behavior of CaBaCo₄O₇ under magnetic field

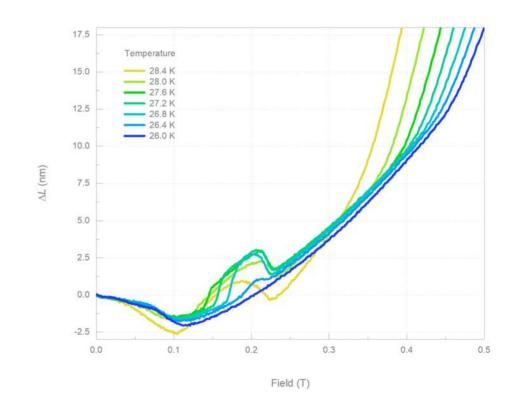




Application (2)-

Magnetostriction behavior of MnSi at different temperatures



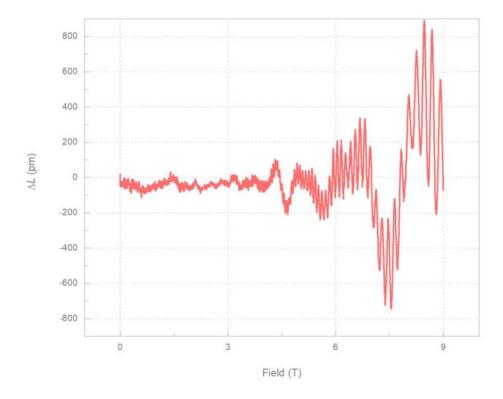


4.4 ThE - Applications

Application (3)–

Magnetostriction behavior of polycrystal aluminum at low temperatures

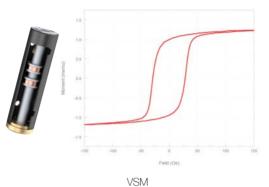




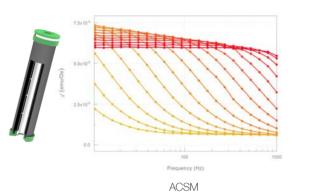
Function

Magnetic Measurements · Series

Functions: M-H (magnetic hysteresis loop), M-T, AC susceptibility, etc...







Suitable for AC susceptibility measurements
Various probes are designed for kinds of materials measurements

1 Work environment	Temperature: 1.4 K \sim 400 K; Pressure: $10^5 \sim 10^{-5} \text{Pa}$; Magnetic Field: $0 \sim 18 \text{Tesla}$;		
2 Diameter	dia-26 mm / dia-30 mm / dia-50 mm		
3 Functions	DC Susceptibility, M-H (hysteresis loop), M-T, FORC (first-order reversal curves), etc	AC Susceptibility vs. frequency / temperature / field, etc	
4 Sample Types	Suitable for all shapes of bulks, films, powders and other forms		
5 Sample requirements	Weight: < 20 g; length in radial dimension: < 3 mm;		
6 Measurement Range	1 × 10 ^{.5} emu ∼ 40 emu	1 × 10 ⁻⁵ emu/Oe ~ 40 emu/Oe	
7 Accuracy	± 0.5%, (using dia. 2.383 mm sphere)	Amplitude: ± 0.5% Phase: ± 0.5 °	
8 Nosie Floor	< 1 × 10 ⁻⁶ emu (1 s)	< 1 × 10 ⁻⁸ emu/Oe (1s)	
9 Compatible options	Standard quartz probe, oxygen-free copper probe, electrically controlled magnetic probes, optically controlled magnetic probes and high-voltage probe are available.		

^{*} The Multifields Technologies magnetic measurements series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others:

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.



Vibrating Sample Magnetometer (VSM)

Magnetic Measurements · Series

Functions: M-H (magnetic hysteresis loop), M-T, AC susceptibility, etc.

High-speed Linear Motor VSM.motor

AC Susceptibility Meter (ACSM)

VSM Meter

- Built-in precise motor control algorithm
- Built-in multi-gain low-noise amplifier makes system suitable for wide-range signal

VSM Probe

- Low-noise first-order gradient coils for
- Low-noise coaxial cable is used for signal
- Low heat leakage ensures low temperature



ACSM Probe

- AC field excitation coil, low-noise detection
- Low-noise coaxial cable is used for signal
- Low heat leakage ensures low temperature

ACSM Meter

- Built-in precise voltage-controlled current
- Built-in three AC susceptibility measurement methods, including one-point, three-point and



• VSM Meter · VSM.Controller





• ACSM Meter · ACSM.Controller

VSM Module - Products List

- VSM Meter · VSM.Controller
- VSM Sensing Probe · VSM.Probe.Coil
- VSM Sample Probe · VSM.Probe.Sample
- Toolbox for Magnetic Measurements · VSM.ToolBox



ACSM Module - Products List

- ACSM Meter · ACSM.Controller
- ACSM Sensing Probe · ACSM.Probe.Coil
- ACSM Sample Probe · VSM.Probe.Sample
- Toolbox for Magnetic Measurements · VSM.ToolBox

5.1 VSM Module - Linear Motor

Complete system including probe, controller, tool box and measurement software.



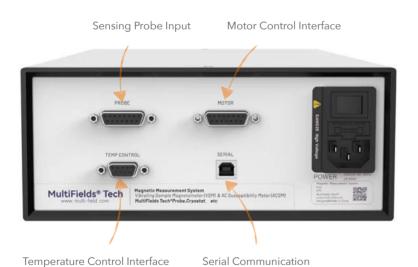
High-Speed Linear Motor - Sepecifications

Performance	
Vibration Frequency	10 ∼ 80 Hz
Vibration Amplitude	0.5 ∼ 4 mm
Full Range	65 mm
Max Force	76 N
Resistance of Coil	3.1 Ohm
Inductance of Coil	3.1 mH
Position Control	
Position Sensor	Optical encoder
Position Resolution	< 1 um
Control Method	PID close-loop control
Dimensions and Interface	
Dimensions	155 * 155 * 232 (mm)
Flange	KF40
Electric Interface	LEMO 26pin (Famale)
Max Power	60 W

5.1 VSM Module

Complete system including probe, controller, tool box and measurement software.







VSM.Controller VSM.Probe.Coil

5.1 VSM Module

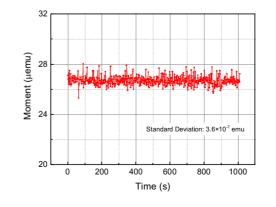
Complete system including probe, controller, tool box and measurement software.

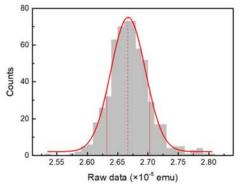
Vibrating Sample Magnetometer - Specifications

5	
Magnetic Moment Measurement	
Temperature	1.4 K ~ 300 K
Magnetic Field	± 18 T
Accuracy	± 0.5% (using dia-2.383mm sphere)
Noise Floor (See example data)	<5×10 ⁻⁷ emu
Measurable Max Moment	40 emu
Vibration Amplitude	2 mm (p - p)
Vibration frequency	40 Hz \sim 65 Hz, 40 Hz (typical)
Average Time	0.5 ~ 100 seconds, 1 second (typical)
Coils Parameters	
Bore Diameter	7.0 mm
Coil Spacing	9.0 mm
Sample Requirements	
Sample Type	Suitable for all shapes of bulks, films, powders and other forms
Sample Requirements	Weight: < 20 g; length in radial dimension: < 3 mm;
Standard Holders	Quartz rod(STD); Quartz tube(STD) Electrically-controlled magnetic probes; Optically-controlled magnetic probes, etc

VSM Options - Specifications

Electrically-controlled Magnetism	
Withstand Voltage	< 200 V (DC)
Leakage Current	< 100 pA @ 100 V (DC)
Electric Channel	2
Additional Noise	< 1×10 ⁻⁷ emu
Optically-controlled Magnetism	
Fiber Diameter	0.2 mm
N.A.	N.A.0.22
Interface	SMA905
Max Power	20 mW
Transmission	0.95 @ 300 K
Additional Noise	< 1×10 ⁻⁷ emu





5.1 VSM Module - Software

Results

Results of magnetic moment measurement can be displayed in real time using the Plot command. Users can plot the graph with different xy axes.

• Sequence list The command list is shown in this section. You can modify or delete one of them. Besides, the command list can be save or open. The sequence status is

VSM Centering

shown in the status bar

The software has a built-in automated sample centre finding process, where the signal-position relationship is determined by scanning the sample position and fitted by a built-in algorithm to accurately determine the sample centre position.



• System Status

The temperature, field and chamber status can be display and modified quickly.

• Measurement command

All measurement commands are listed, including temperature and field settings, magnetic moment measurement commands. The arrangement of these commands allows for automated measurements.

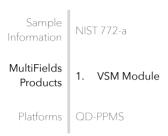
• Sample instal / uninstall

Automatic sample installation/ uninstallation process is built into the software, which automatically controls the motor to move the sample probe to the loading port without any unnecessary operation.

5.1 VSM Module - Application

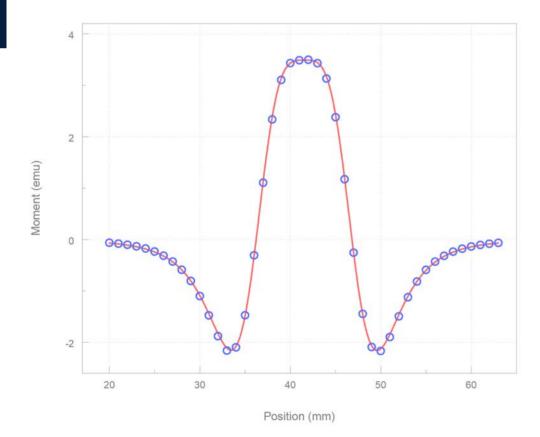
Complete system including probe, controller, tool box and measurement software.

Application (1)— Demonstration of the VSM automatic center finding

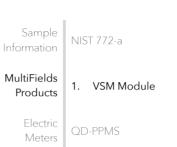


Method

Before the magnetic moment measurement, the sample needs to be placed at the centre of the sensing coils. Multifields VSM includes an automatic centering procedure, which accurately moves the sample to the center of the coils.

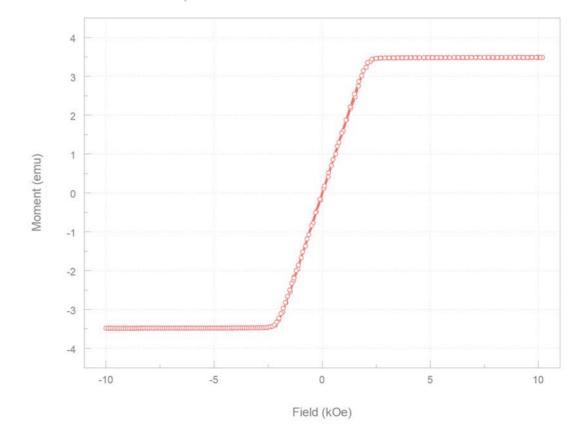


Application (2)— Hysteresis loop of pure Ni sphere (NIST 772-a)



Accuracy

We conducted measurement on the traceable standard sample NIST 772-a using the Multifields VSM module, and the obtained accuracy is better than $\pm 0.5\%$



5.1 VSM Module - Application

Complete system including probe, controller, tool box and measurement software.

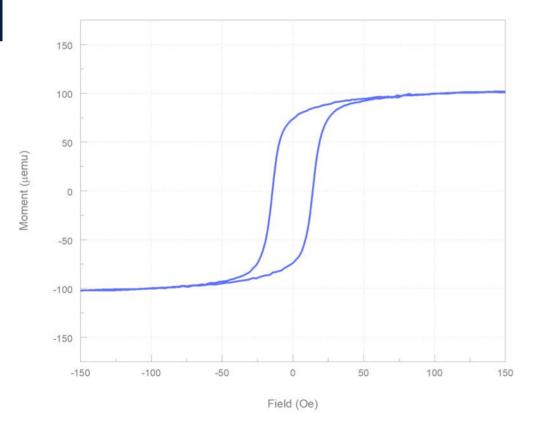
Application (3)—

Hysteresis loops of ferrimagnetic YIG thin-film

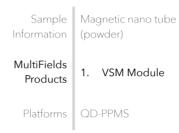


Sensitivity

Multifields VSM has a noise level of approximately 5 x 10-7 emu at the minimum range, allowing a reliable measurement results for samples with a magnetic moment of 10-6 emu.

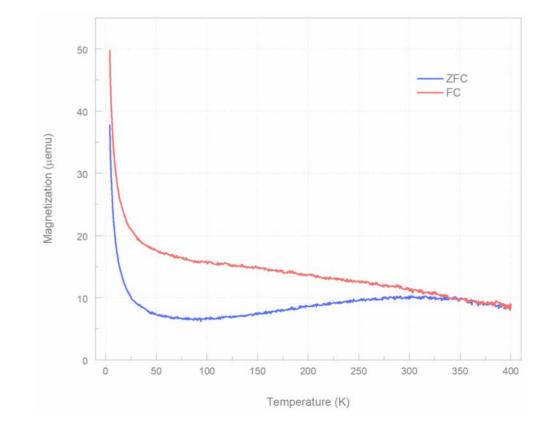


Application (4)— M-T curves of magnetic nanotubes with FC and ZFC



Method

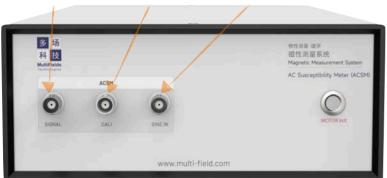
After cooling the sample with / without magnetic field, conducting the magnetization measurement during the warming precess could obtain the FC and ZFC curves, which reflects the magnetic transition of the sample.



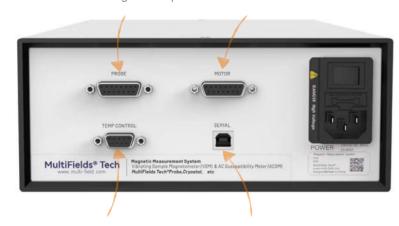
measurement software.

Complete system including probe, controller, tool box and

MultiFields & Group



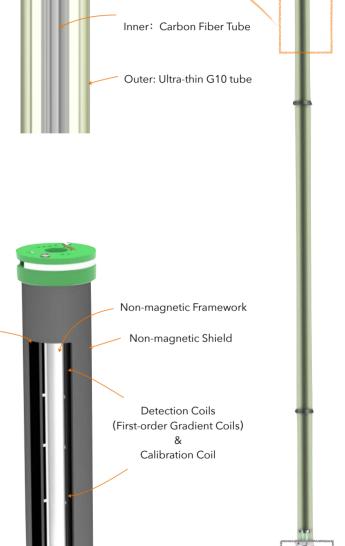
Sensing Probe Input Motor Control Interface



Temperature Control Interface Serial Communication

• Structure of Sensing Probe

Constructed of ultra-low thermal conductive G10 and carbon materials. It has relatively high mechanical strength and ensures the sample reaching lowest temperature.



Detection Coils

The detection coil is constructed with a completely non-magnetic material as its framework, and pure copper enameled wire which is wound to form a first-order gradient coil for induced voltage measurements. It is also installed with a Cernox sensor for temperature monitoring.

Driving Coil

ACSM.Probe.Coil

Materials Characteriza

5.2 ACSM Module - Specifications

Complete system including probe, controller, tool box and measurement software.

AC Susceptibility Meter - Specifications

Measurement	
Temperature	1.4 K ~ 300 K
Magnetic Field	± 18 T
Sensitivity	1×10 ⁻⁸ emu/Oe
Phase Accuracy	± 0.5 °
Driving Field	0.05 ~ 15 Oe
Frequency	10 Hz ∼10 kHz
Average Time	0.5 ~ 100 seconds, 1 second (typical)
Coils Parameters	
Bore Diameter	8.0 mm
Detection Coil Spacing	9.0 mm
Sample Requirements	
Sample Type	Suitable for all shapes of bulks, films, powders and other forms
Sample Requirements	Weight: < 20 g; length in radial dimension: < 3 mm;
Standard Holders	Quartz rod(STD); Quartz tube(STD) Electrically-controlled magnetic probes; Optically-controlled magnetic probes, etc

ACSM Options - Specifications

Electrically-controlled Magnetism	
Withstand Voltage	< 200 V (DC)
Leakage Current	< 100 pA @ 100 V (DC)
Electric Channel	2
Additional Noise	< 1×10-7 emu
Optically–controlled Magnetism	
Fiber Diameter	0.2 mm
N.A.	N.A.0.22
Interface	SMA905
Max Power	20 mW
Transmission	0.95 @ 300 K
Additional Noise	< 1×10-7 emu

5.2 ACSM Module - Software

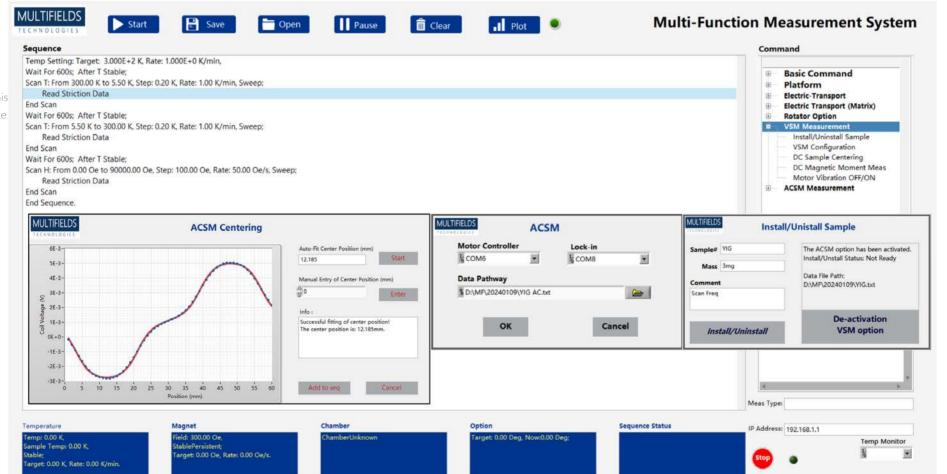
Complete system including probe, controller, tool box and measurement software.

• Sequence list

The command list is shown in this section. You can modify or delete one of them. Besides, the command list can be save or open. The sequence status is shown in the status bar.

ACSM Centering

The software has a built-in automated sample centre finding process, where the signal-position relationship is determined by scanning the sample position and fitted by a built-in algorithm to accurately determine the sample centre position.



Results

Results of AC Susceptibility measurement can be displayed in real time using the Plot command. Users can plot the graph with different xy axes.

System Status

The temperature, field and chamber status can be display and modified quickly.

• Measurement command

All measurement commands are listed, including temperature and field settings, magnetic moment measurement commands. The arrangement of these commands allows for automated measurements.

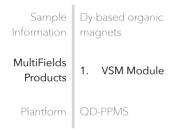
• Sample instal / uninstall

Automatic sample installation/ uninstallation process is built into the software, which automatically controls the motor to move the sample probe to the loading port without any unnecessary operation.

5.2 ACSM Module - Application

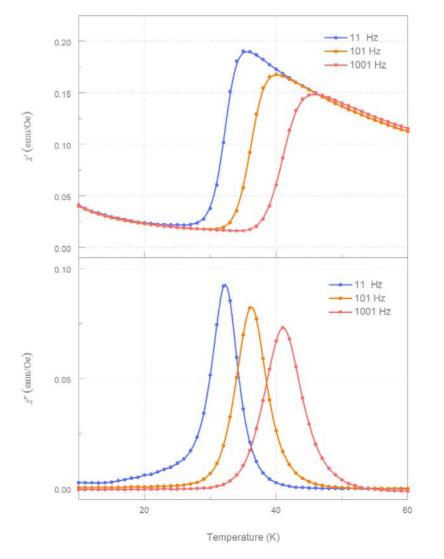
Complete system including probe, controller, tool box and measurement software.

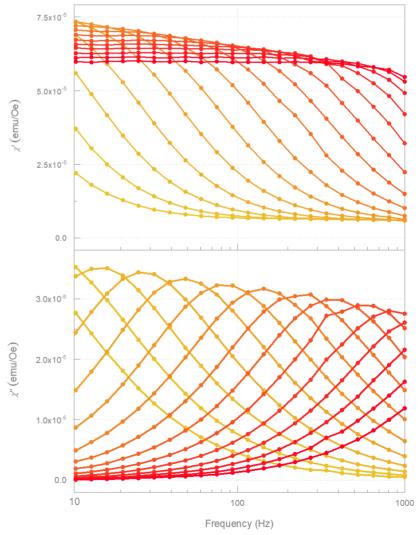
Application (1)— AC susceptibility of Dy-based organic magnets as a function of frequency and temperature



• Measurement Method

AC susceptibility measurement can be conducted in a variety of methods. Two-points, three-points, and five-points measurements are commonly used, which are also built in the Multifields ACSM system.





MultiFields & Group

5.3 VSM & ACSM - Accessories

Complete system including probe, controller, tool box and measurement software.

VSM.ToolBox



VSM.SampleBase

VSM & ACSM Accessories List

	Items	Specifications	Quantity		
Sta	Standard Sample				
1	Standard Sample	Pure Pd, 0.27g	1		
Sai	mple Holder				
2	Quartz Rod	dia.3 mm, length 120 mm	2		
3	Quartz Tube	dia.3 mm, length 120 mm	2		
4	Sample Base		1		
Ad	Adhesive				
5	GE-Vanish	Low-temperature adhesive, 20 mL	1		
То	Tools				
6	Sticks	Non-magnetic, length 140 mm	1 pc		
7	Screws	M3, L3	2 pc		
8	Scissor		1 pc		

Magnetoelectric Measurements · Series

Function: Dielectric coefficient and impedance measurement, ferroelectric properties (P-E loop, fatigue, etc.) and magneto-electric coupling coefficients, etc..





Dielectric Measurement

Capacitance, dielectric coefficient, high resistance, P-E loop (< 200 V) measurements can be realized;

Function

Ferroelectric Measurement

Measurements of ferroelectric properties such as P-E loop (1000 V), fatigue, and imprint can be realized; High-voltage protected design compatible with third-party platforms

Magneto-electric Coupling Measurement

Measurement of the magneto-electric coupling coefficient can be realized, and the direction of the magnetic field can be changed by using sample holders with different configurations.

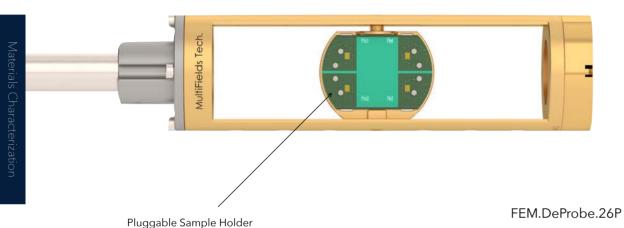
	·	compatible with third-party platforms	sample holders with different configurations.
1 Work Environment	Temperature: 1.4 K \sim 400 K; Pressure: $10^5 \sim 10^{-5} \text{Pa}$; Magnetic Field: $0 \sim 18 \text{Tesla}$;		
2 Diameter	dia-26 mm / dia-30 mm / dia-50 mm		
3 Function	Capacitance, dielectric coefficient, impedance and high resistance Compatible with P-E loop and other ferroelectric measurements.	P-E loop, fatigue, imprint and pyroelectric, etc.; Compatible with capacitance, dielectric coefficient, impedance measurements.	Magneto-electric coupling coefficient measurement
4 Sample Type	Bulks & thin-film	Bulks	Bulks & thin-film
5 Sample Requirements	< 10 mm × 10 mm × 5 mm	< 8 mm × 8 mm × 3 mm	< 6 mm × 6 mm × 3 mm
6 Voltage Range	< 200 V DC	< 1000 V DC	N. A.
7 Frequency Range	0.1 Hz \sim 10 MHz;	0.1 Hz ~ 300 kHz	0.1 Hz ~ 100 kHz
8 Leakage Current	~ 10 fA @ 100 V		< 1 pA @ 100 V
9 Parasitic Capacitance	< 10 fF		
10 Options	Ceramic sample holder with ultra-low leakage current、Ferroelectric Analyzer; Optional optical fiber for combined optoelectronic measurements.		Perpendicular/in-plane magnetic-electric sample holders; commercial lock-in amplifiers and other instruments

^{*} The Multifields Technologies magnetoelectric measurements series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others;

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.

6 Dielectric Measurement (DEM)

Compatible with dielectric, ferroelectric, pyroelectric, etc. measurements for bulks and films



- 1. Ultra-low parasitic capacitance, < 10 fF
- 2. Ultra-high Voltage, > 3 kV
- 3. Ultra-low background current, ~ 10 fA

Key Features

- Working temperature: 1.5 ~ 400 K, Max field: 18 T;
- Dielectric probe enables dielectric/ferroelectric/multiferroic measurement
- Dielectric, ferroelectric and pyroelectric measurements for thin-film and bulk samples can be realized.
- Pluggable sample holder with unique guard design for extremely low parasitic resistance
- Optional low-temperature optical fiber for combined optical-electric measurements
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms.

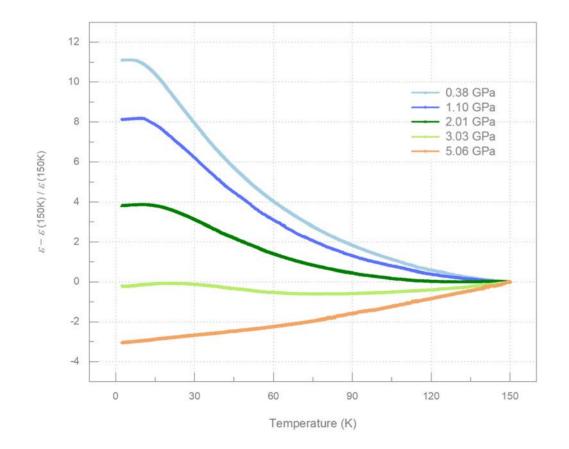
Dielectric Measurement - Specifications

Probe	
Temperature	1.5 ∼ 400 K
Magnetic Field	0 ~ 14 T
Withstand voltage	400 V
Frequency Range	20 Hz ∼ 300 kHz
Measurement Precision	0.05%
Leakage current	< 5 × 10·14 A
Parasitic Capacitance	< 10 fF
Channel	4
Cable Type	Cryogenic coaxial cable
Function	Dielectric, ferroelectric and pyroelectric measurements for thin-film and bulk samples
Dielectric Sample Holder	
Parasitic Capacitance	< 10 fF
Withstand voltage	3000 V
background current	~ 1 × 10 ⁻¹⁴ A
Current Range	0.1 pA ~ 1 A

6 DEM - Application

Application (1)—
Dielectric constant of BaFe₁₂O₁₉ under different pressures

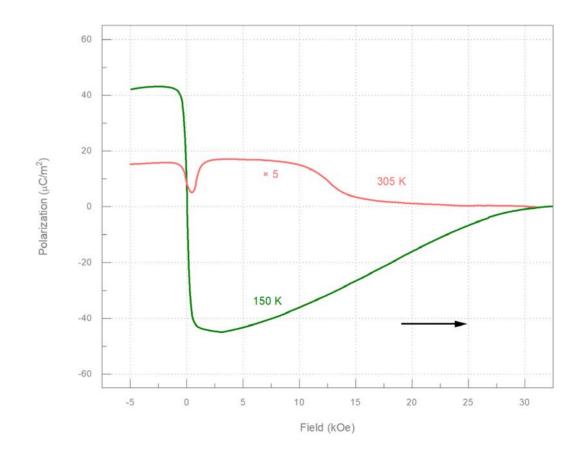




Application (2)—

Magneto-current measurement at different temperature of Fe Oxide

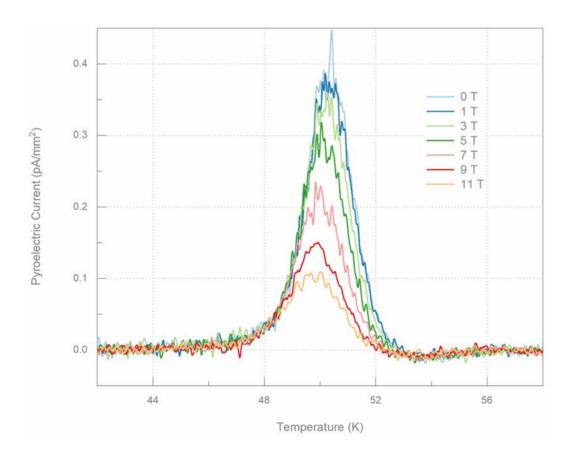




6 DEM - Application

Application (3) — Pyroelectric effect of YFeO₄ under different magnetic fields



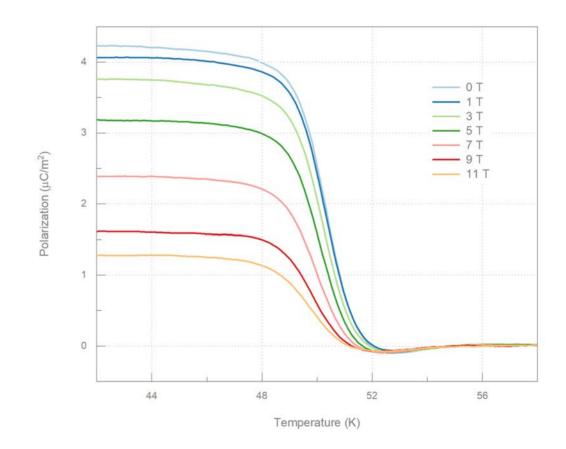


• What is the pyroelectric effect?

When the temperature changes, the macroscopic polarization of the material changes. As a result, the shielding charge on the surface of the material is out of balance and the excess shielding charge is released to form a detectable current, i.e. the pyroelectric effect.

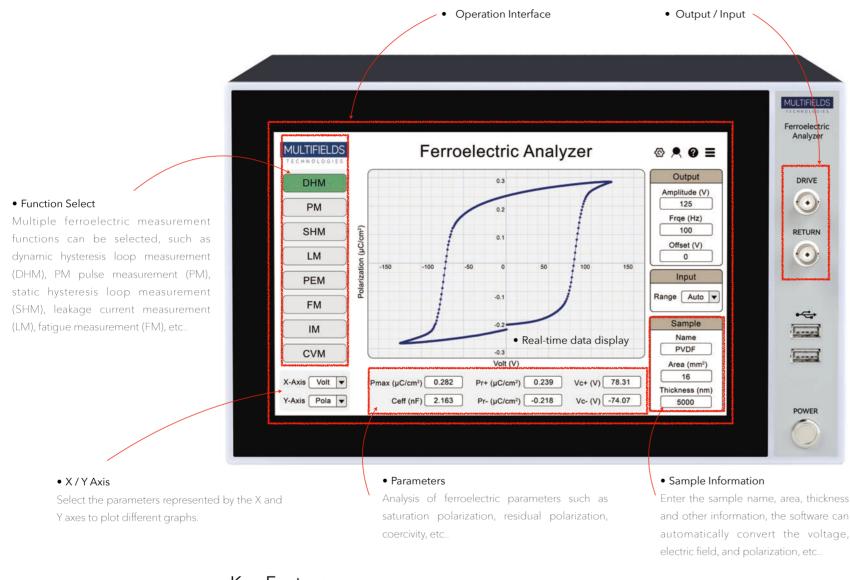
• How to measure pyroelectric effect?

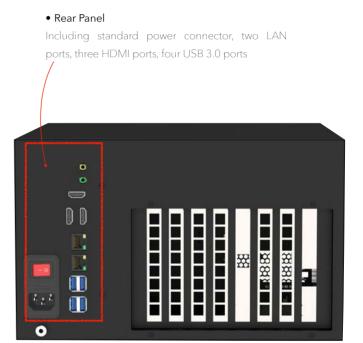
1. Pre-polarization: apply a voltage to the ends of the sample while cooling the sample to desired temperature; 2. Current measurement: withdraw the voltage, connect an electrostatic meter, and increase the temperature at a fixed rate while monitoring the current of the electrostatic meter. The current show peaks when the electrostatic polarization variation is greatest (as shown in the left figure below). Integrate the current against the time to obtain the relationship between polarization and temperature (as shown in the right figure below).



7 Ferroelectric Measurement (FEM) - Analyzer

Complete system including probe, controller and measurement software.





FEM.Analyser

Key Features

- Ferroelectric analyzer combining FEM probes provides a integrated ferroelectric measurement solution;
- Dielectric, ferroelectric and pyroelectric measurements for thin-film and bulk samples can be realized.;
- Fatigue and imprint measurement can be realized.

- Optional low-temperature optical fiber for combined optical-electric measurements
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms.

7 FEM - Ferroelectric Analyzer

Ferroelectric Analyzer - Specifications

Ferroelectric Measurement		
Arbitrary Waveform Generator	50 MSa/s *	
Analog Output	2 MHz,24 bits	
Output Volltage	± 10 V	
Output Impedance	10 Ohm	
Max Hysteresis Frequency	100 kHz	
Min Hysteresis Frequency	0.01 Hz	
Min Pulse Width	0.5 µs	
Min Rise Time	100 ns	
Max Fatigue Frequency	2 MHz	
Slew Rate	> 200 V / µs	
Max Capacitive Load	1 µF	
Max Output Current	± 1 A	
Current Range	1 pA ~ 1 A	
Function	Dynamic hysteresis loop measurement (DHM), fatigue measurement (FM) retention measurement (RM), imprint measurement (IM) leakage current measurement (LM), capacitance measurement (CVM) piezoelectric measurement (PZM), pulse measurement (PM) pyroelectric measurement (PYM), dielectric measurement (DEM)	
Suitable Probe	FEM.DeProbe, FEM.FeProbe	

^{*} SPS: Sample per second

High-Voltage Amplifier (Optional) - Specifications

	Amplifier - 10k	Amplifier - 1k
Voltage Range	± 10 kV	± 1 kV
Current Range	0 ∼ 2 mA	0 ~ 20 mA
Max Frequency	600 Hz	40 kHz
Input Impedance	10 kOhm	10 kOhm
DC Voltage Gain	1000 V / V	100 V / V
DC Voltage Gain Accuracy	优于 0.3 %	优于 0.5 %
DC Voltage Bias	< 2 V	< 1 V
Output Noise	< 700 mV rms	< 30 mV rms
Slew Rate	35 V / µs	150 V / µs
Stabilization time for 1% change	< 1 ms	< 30 µs
Inner Capacitance	300 pF	300 pF
Voltage Monitoring	Amplifier - 10k	Amplifier - 1k
Analog Output Scale	1/1000 of the output voltage	1/100 of the output voltage
Noise	< 20 mV p-p	5 mV rms
DC Accuracy	< 2 %	< 2 %

7 FEM - Probe

High-voltage ferroelectric probe, compatible with dielectric and pyroelectric measurements

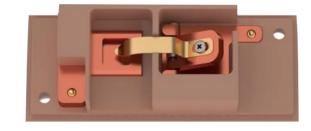
• Sample Capsule

Highly insulating Vespel material is used to increase breakdown voltage and ensure stable use under high voltage.



• Sample Fixture

The sample to be measured can be directly clamped between the two electrodes, with convenient and quick operation.



FEM.FeProbe.30

Key Features

- ⁻ Temperature: 1.5 ~ 400 K; Magnetic field: 18 T
- FEM probe combining Ferroelectric analyzer provides a integrated ferroelectric measurement solution;
- Dielectric, ferroelectric and pyroelectric measurements for bulk samples can be realized.;
- Fatigue and imprint measurement can be realized.
- Optional low-temperature optical fiber for combined optical-electric measurements
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms.

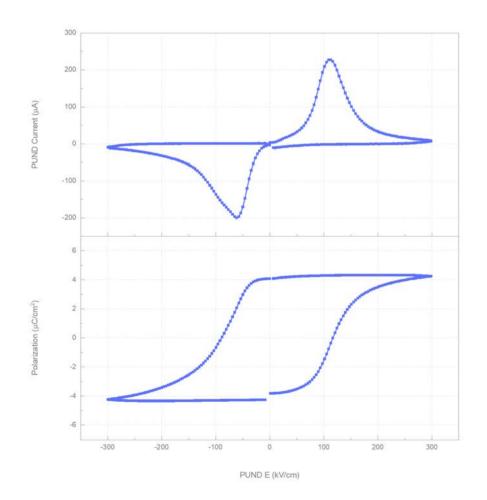
7 FEM - Application

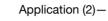
Application (1)—

P-E loop of PZT thin film

Sample Information 500nm PZT thin film

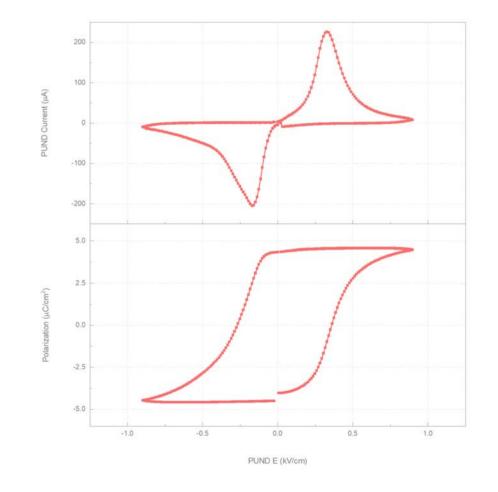
MultiFields Products 1. FEM.Analyser 2. FEM.Probe





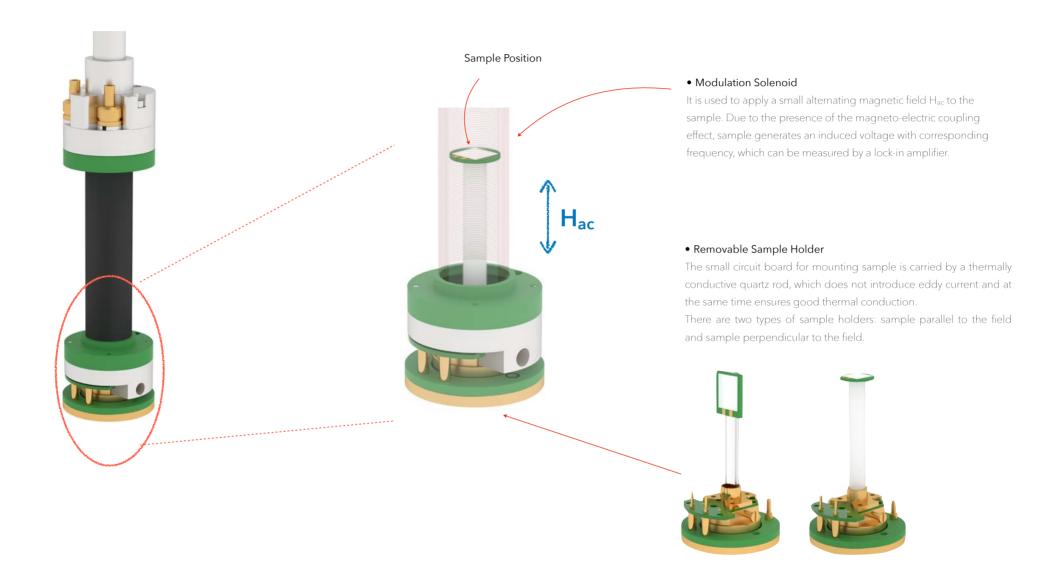
P-E loop of PMN-PT Bulk





8 Magneto-electric Coupling Measurement

Magneto-electric coupling coefficient measurement system with ultra-high sensitivity



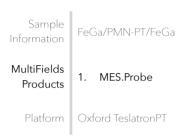
Key Features

- Magneto-electric coupling coefficient measurement system with ultra-high sensitivity
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms.

8 Magneto-electric Coupling Measurement - Application

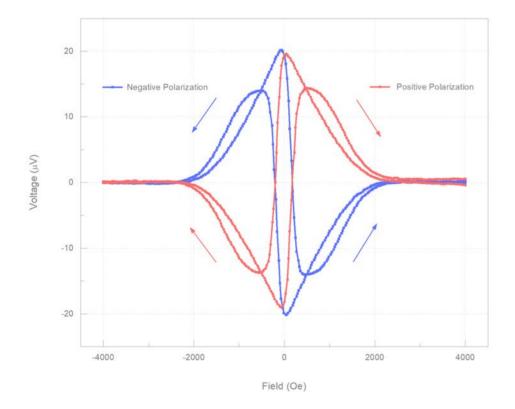
Application (1)—

Magneto-electric coupling effect of FeGa/PMN-PT/FeGa heterojunction



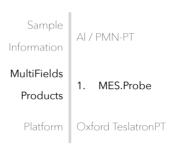
Method

A thin film of FeGa layer, a material with magnetostriction effect, is grown on a piezoelectric substrate PMN-PT. This composite magneto-electric coupling material generates an induced voltage under the excitation of a magnetic field, which can be detected by a lock-in amplifier.



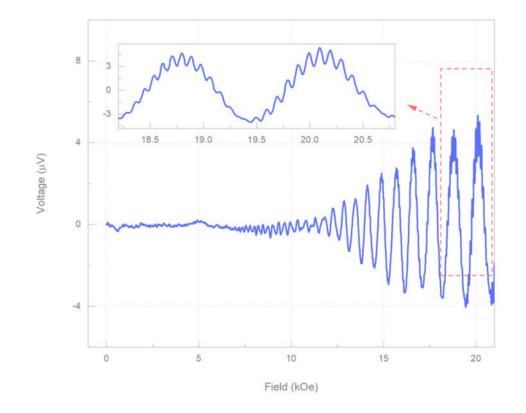
Application (2)-

Measure de Haas oscillation of Al Magneto-electric Coupling Measurement



• Principle

The aluminum with de Haas oscillation effect is bonded with the piezoelectric material PMN-PT. A extremely slight dimensional oscillation occurs in Al under the magnetic field, which is converted into a piezoelectric voltage on the PMN-PT.





Ferromagnetic Resonance Measurement · Series









FMR (H in plane)

FMR (H out of plane)

ST-FMR (H in plane)

ST-FMR (H out of plane)

Function

FMR、Spin pumping & ISHE measurements for thin-film and bulk can be realized. Provides DC channels for electric-modulated FMR researches.

ST-FMR、Spin pumping & ISHE measurements for device can be realized. Provides DC channels for electric-modulated ST-FMR researches.

1	Work environment	·Temperature: 1.4 K \sim 400 K; Pressure: $10^5 \sim 10^{-5}$ Pa; Magnetic Field: $0 \sim 18$ Tesla;				
2	Diameter	dia-26 mm / dia-30 mm / dia-50 mm				
3	Max Frequency		20 / 40 GHz			
4	RF loss (Input to sample)		20 GHz version: -6 dB (@ 20 GHz), -18 dB (@ 40 GHz) 40 GHz version: -4 dB (@ 20 GHz), -9 dB (@ 40 GHz)			
5	Leakage current	< 100 pA @ 100 V				
6	RF Channel	2				
7	DC Channel	6	6	8	6	
8	Magnetic Field	Field parallel to sample plane Field perpendicular to sample plane		Field parallel to sample plane	Field perpendicular to sample plane	
9	Sample Type	Thin-film / bulk sample (mounting on CPW surface)		Micro / nano device (wire-bonding the CPW and device)		
10	Function	FMR, Spin Pumping	g - ISHE voltage measurement	ST - FMR, Spin Pumping - ISH	HE voltage measurement	
11	Compatible Meters	Multifields FMR Workstation, co	ommercial vector network analyzer, etc	Multifields FMR Workstation, comr	nercial signal generator, etc	

^{*}The Multifields Technologies FMR measurements series are seamlessly compatible with common platforms such as QD-PPMS, Oxford-TeslatronPT, Pride-CPMS, Cryogenic-CFMS and others;

^{**} The above are all recommended configurations. Multifields Technologies provides customization services. If you have special requirements, please contact us.



9. FMR Measurement

Integrating FMR, ST-FMR, Spin Pumping & ISHE into one system and exhibiting extraordinary sensitivity to measure magnetic film.

FMR Measurement System - Specifications

Operating Environment				
Frequency Range	1∼20 GHz	1~40 GHz		
Max Power	27 dBm	27 dBm @ < 35 GHz 22 dBm @ 35~40 GHz		
Power Step	0.1 c	lBm		
Frequency resolution	0.01	GHz		
Frequency Stability/Accuracy	2 pp	om		
SSB Phase Noise	< -70 dBc/F	Hz @ 1 kHz		
Nonharmonics	< -60	dBc		
Harmonics	< -35 dBc (@ 6GHz以上) < -25 dBc (@ 6GHz以下)			
Measurement Function	FMR, ST-FMR, ISHE& Spin pumping			
Auxiliary function	AC modulation current output; Amplitude modulation			
Hight	2 (J		
Communication	RS2	32		
Software				
Environmental control	Temperature, r	magnetic field		
Application	FMR, ST-FMR, ISHI	E&Spin pumping		
Data fitting	Lorentzian fitting, Gaussian fitting, Kittel fitting,			
Parameters	Resonance magnetic field (H_r), Resonance frequency (f_r), Resonance linewidth (Δ H), Damping (α), Gyromagnetic ratio (γ), g factor, Effective magnetization (M_{eff}), ISHE voltage			
Sweeping mode	Field Sweeping: RF frequency is kept constant and field is swept			

*If	you want to	use other instrur	nents for FMR	measurement,	please consult us.
-----	-------------	-------------------	---------------	--------------	--------------------

FMR Probe			
Туре	In plane	Out of Plane	
Function	FMR, ST-FMR, ISHE&Spin pr	umping (thin-film and bulk)	
Frequency Range	0~20 GHz,	0~40 GHz	
Compatible Platforms	Multifields cryogenic and magnetic field platform Coldtube PPMS, TeslatronPT, Cryogenic, Pride-CPMS, etc		
CPW	Through CPW,	6 DC channels	
Sample Area	10 mm x	10 mm	
	Max Freque	ncy: 10 kHz	
Helmholtz Coils (Modulation Coils)	Max Current: 100 mA		
	Field/current coefficient 0.08 Oe/ mA		
ST-FMR Probe	e		
Туре	In plane	Out of Plane	
Function	FMR, ST-FMR, ISHE&Spin p	umping (micro-size device)	
Frequency Range	0~20 GHz,	0~40 GHz	
Compatible Platforms	Dia.25mm, compatible with third-party cryogenic supercond magnet platforms; Low-temperature rotating ST-FMR measurement can be realized ColdTUBE provided by Multifields Technologies		
CPW	2 channels, open GSG electrodes		
Crvv	8 DC channels 6 DC channels		
Sample Area	8 mm x 9 mm 6 mm x 7 mm		

MultiFields® FMR Measurement Meter is a very powerful. It can replace expensive VNA to perform the

measurements under extreme conditions (usually large RF loss). Thanks to MultiFields® Technologies advanced measurement and integration technology, a multifunctional measurement meter includes FMR, ST-FMR & ISHE & Spin pumping is achieved. It is aimed for testing films with high signal-to-noise ratio that attributes to combine with the (built-in) lock-in amplifier, AC modulated coils and special FMR probe

FMR measurements with a high output power up to 27 dBm, which is suitable for high-frequency

for cryogenic and magnetic platform.

9.1 FMR Workstation

Integrating FMR, ST-FMR, Spin Pumping & ISHE into one system and exhibiting extraordinary sensitivity to measure magnetic film.

• Reference Input • DC Breakout Module External low-frequency modulation signals are • RF Output The DC electrodes on the probe are converted fed to the instrument to control the current Outputs microwave signal up to 20/40 to 6 BNC connectors and connected directly to output of the AC modulation coil (FMR Mode) GHz with continuous wave or amplitude a DC source meter, which enables electricallyor to control the amplitude modulation of the modulation modes. modulated (ST-)FMR measurement or microwave (ST-FMR Mode). independent electric measurements MultiFields® Tech 物性测量·磁学 Ferromagnetic Resonance Unit Ferromagnetic Resonance Measurement System (FMR) Mode: FMR Frequency: 1.00 GHZ Power: 0.0 dem ON/OFF • Modulation Current Output FMR.Meter.20/40 The modulated current is applied into Helmholtz coils. Introducing an AC small

Key Features

Max frequency: 20 GHz & 40 GHz:

signal-to-noise ratio can be obtained

- Max power output: 27 dBm;
- Extraordinary sensitivity to measure magnetic film with thickness of 1 nm;

magnetic field during the FMR measurement, together with a lock-in amplifier to read the output signal, a microwave absorption differential spectrum with a high

- Iunable frequency with resolution of 10 MHz; tunable power with resolution of 0.1 dBm,
- The FMR workstation with a voltage controlled current source and microwave amplitude modulation can conduct EMR. ST-FMR, ISHE & Spin-Pumping measurements:

9.1 FMR Measurement - Software

Integrating FMR, ST-FMR, Spin Pumping & ISHE measurements into one software

Measurement Result

The HCM results will be shown in this figure.

Setting Zone

The platform, sample information, instrument selection can be setting in this zone.

• Measurement sequence

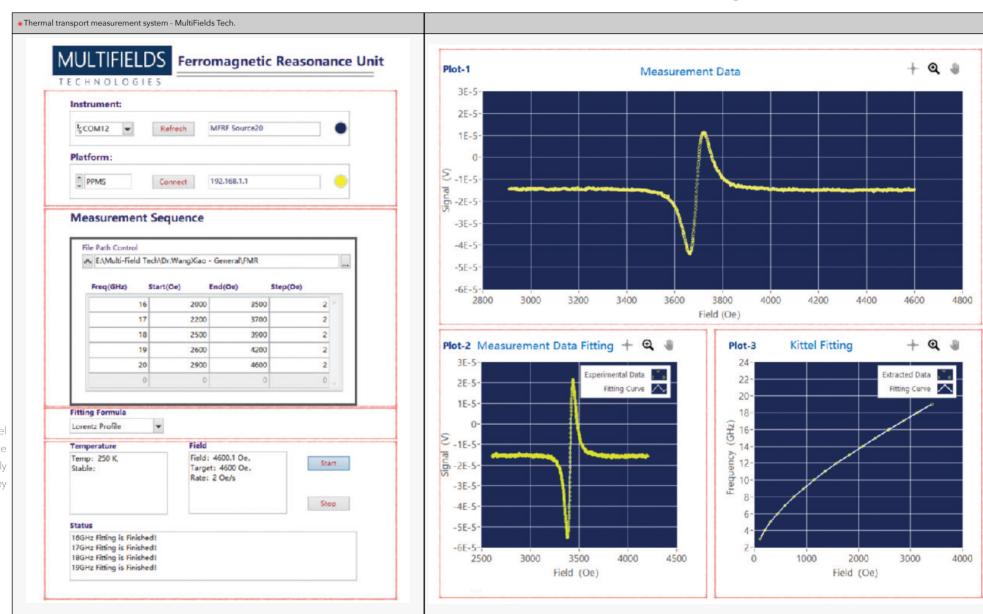
Selecting the file path to save the data and setting the parameters such as frequency and field.

Data Fitting

Selecting appropriate function/model to fitting the FMR spectra. The extracted parameters are subsequently plotted and fitted to calibrate the key results.

• System Status

The temperature, field and chamber status can be display and modified quickly.

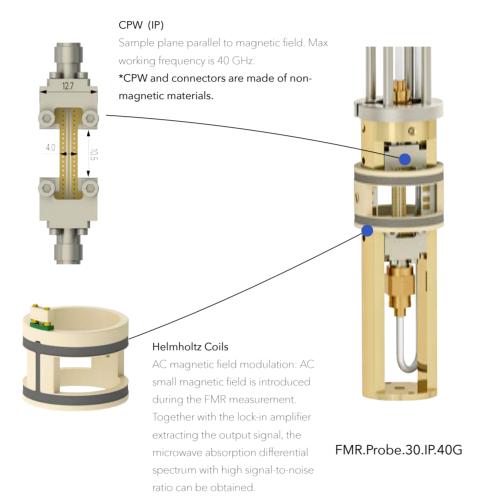


The fitting result of the FMR spectra obtained from the latest measurement. The parameters (resonant frequency and field) are extracted.

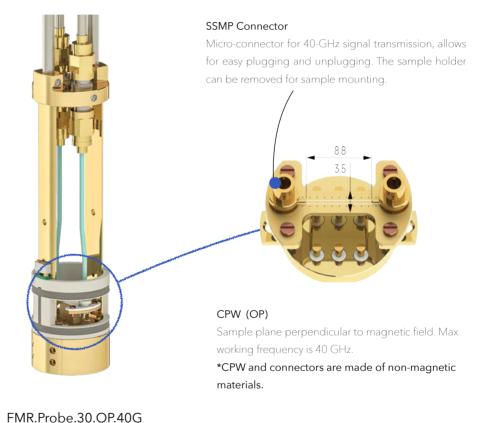
The fitting result using Kittel equation. Parameters such as effective magnetization, anisotropic field, Landé q-factor and damping coefficient can be obtained.

9.2 FMR Measurement - Probe

High-frequency measurements on thin-film samples, with sample perpendicular/parallel to magnetic field configurations



The CPW with 50 Ω -characteristic impedance is fabricated on the Rogers 4003C substrate. In order to improve the signal-to-noise ratio, a compact Helmholtz coil is assembled near the sample to provide a modulation field. The change of microwave absorption induced by the sample placed on the CPW of the MultiField® FMR probe, can be detected by the MF Microwave Core or a lock-in amplifier. Thus, differentiation of microwave absorption signals can be obtained



Key Features

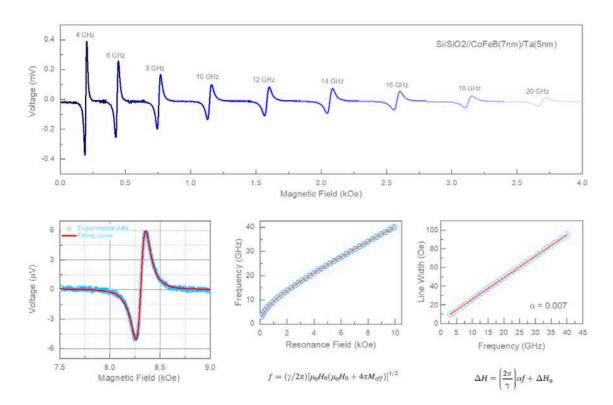
- Extraordinary sensitivity to measure magnetic film with thickness of 1 nm;

- Probe working temperature: 1.5 ~ 400 K; Max magnetic field: 18 Tesla;
- Rotating FMR measurement can be conducted using Multifields ColdTUBE;

9.2 FMR Measurement - Applications

Application (1)-

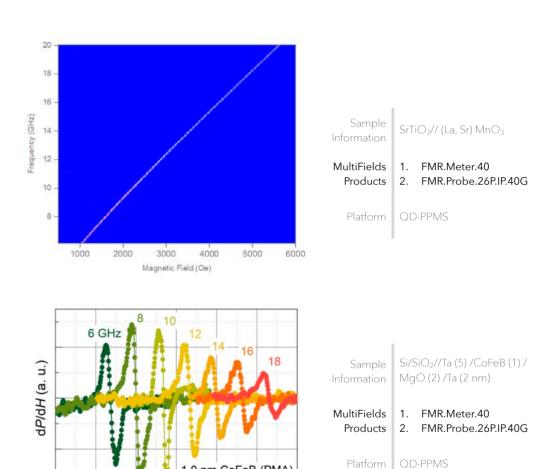
FMR results of ferromagnetic film





• In-plane CoFeB Thin-film

Significant FMR spectra induced by a thin-film sample with structure of CoFeB (7nm) /Ta (5nm) are obtained, it shows a good SNR even the frequency up to 40 GHz. The measurement data can be well fitted to a Lorentzian function consisting of a symmetric and an anti-symmetric Lorentzian component. The figures show the resonance frequency as a function of the resonant field, they are perfectly fitted by the Kittel equation



• Perpendicular CoFeB thin-film

3

4

5

H (kOe)

2

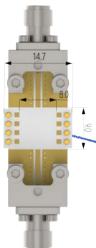
Benefiting from the ultra-high signal-to-noise ratio, 1nm CoFeB thin film with perpendicular anisotropy is well detected by MultiFields® FMR Probe

1.0 nm CoFeB (PMA)

6

9.3 ST-FMR Measurement - Probe

High-frequency measurements on micro-size devices, with sample perpendicular/parallel to magnetic field configurations



Open-CPW (IP)

The sample holder contains 2 open GSG electrodes and 6 DC electrodes, all of which can be directly wire bonded by ultrasonic welding.

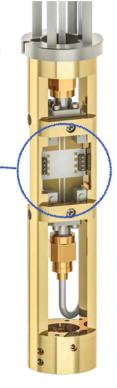
*CPW and connectors are made of nonmagnetic materials.



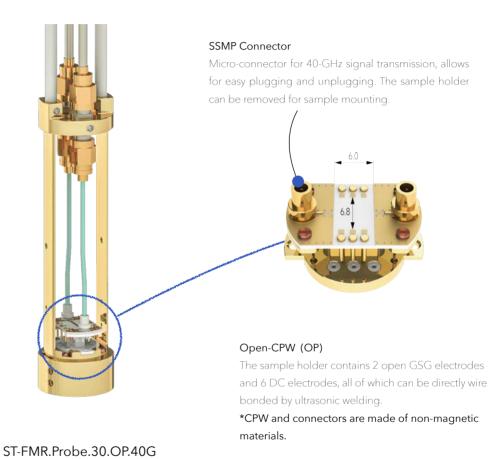
Option: Helmholtz Coils

ST-FMR measurement generally utilizes the microwave amplitude modulation method and the Helmholtz coil is not installed as standard. However it can be installed as an option to meet unique requirements.

ST-FMR.Probe.30.IP.40G



For the micro-fabricated magnetic device, spin rectification which originates from magnetoresistance effect is a powerful method to characterize its FMR properties. Especially in the field of spintronics, this method is commonly called spin-torque ferromagnetic resonance (ST-FMR). In addition to characterizing the fundamental magnetic properties, it is very useful to characterize the spin-related properties such as spin-orbit torque efficiency, spin transport etc...



Key Features

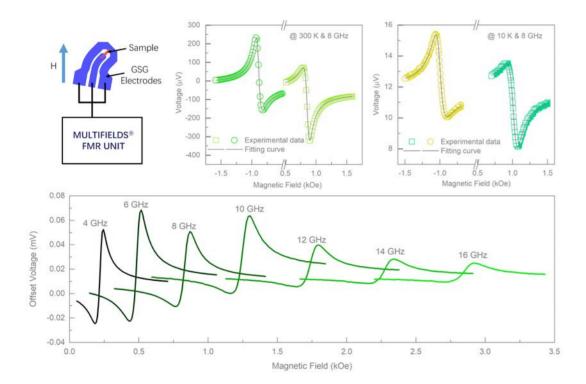
- Max frequency: 20 GHz & 40 GHz:
- Connect the samples by wire bonding directly on the sample holder (CPW)
- Two configuration satisfy most measurement requirements

- Probe working temperature: 1.5 ~ 400 K; Max magnetic field: 18 Tesla;
- Rotating FMR measurement can be conducted using Multifields ColdTUBE;
- Compatible with QD-PPMS Dynacool, Oxford-TeslatronPT, Cryogenic and Pride-CPMS platforms.

9.3 ST-FMR Measurement - Applications

Application (1)-

ST-FMR measurement of FM / HM device



Sample Information MultiFields Products

Si/SiO₂/CoFeB (7 nm) /Ta (5 nm)

elds 1. FMR.Meter.40 ucts 2. ST-FMR.Probe.26P.IP.40G

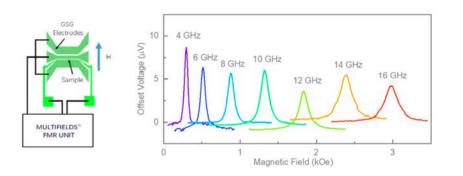
Electric Meters | QD-PPMS

• ST-FMR of NiFe/Pt

One patterned device with structure of NiFe (5 nm) /Pt (5 nm) are connected with the ST-FMR Probe by wire-bonding (Au wires recommended for higher frequency). A microwave-frequency (GHz) charge current with a power of 10 dBm and amplitude-modulated (773 Hz) by the lock-in amplifier was applied to the Probe. The rectified voltage was detected by a lock-in amplifier.

Application (2)-

Spin pumping & ISHE measurement of FM / HM device



Sample Information Si/SiO₂// NiFe (7 nm) /Ta (5 nm)

MultiFields Products 1. FMR.Meter.40
2. ST-FMR.Probe.26P.IP.40G

Electric Meters QD-PPMS

• Spin-pumping of NiFe/Ta

The patterned device with structure of NiFe (7 nm) /Ta (5nm) are connected with the **MultiFields® ST-FMR Probe** by wire-bonding (Au wires recommended for higher injection efficiency). An in-plane magnetic field with a fixed direction that cross the sample stripe was swept. The inverse spin Hall voltage can be well fitted to a Lorentzian function.

Spin pumping is a common way to generate a spin current, which can be detected by inverse spin Hall effect (ISHE). Combination of these two effects can measure many important spin-related properties of the materials, such as interfacial spin transport, spin Hall efficiency etc.. Meanwhile, because the spin pumping effect is accompanied with ferromagnetic resonance, the fundamental magnetic properties are also reflected.

Confocal Optical Measurement - Overview

All-in-one solution for cryogenic confocal measurement, including confocal scanning microscopy,



• MOKE Measurement

• Raman spectroscopy

• Fluorescence Collection

• Transport/gate applications

• Temperature monitor and control

• Microwave/radio frequency cables

10.1 SFM - Raman / Fluorescence Spectroscopy

Integrated Raman/fluorescence measurement module, which can be directly mounted on confocal sample probes 1" optics mount Rotatable filters Fluorescence / Raman signal collection layer CFM.SFM.Raman FC/PC port SM or MM optical fiber Signal collection Illumination / Observation layer Integrated CMOS Removable BS camera Minimize signal reduction Illumination light port Multi-mode fiber **Excitation layer** SM fiber port (APC) Pogo-pin Connectors piezo-driving optics, including waveplate and polarizers Beam splitter: cubic BS,

plate BS, dichroic mirror

Key Features:

- Confocal scanning probe based on optical fiber Available core dimensions: 4, 10, 25, 50, 100, 200 µm
- Exchangable optics for various wavelength applications
- Kohler illumination enabled large-area/homogeneous illumination $\Phi_{\text{FOV}}{\sim}30~\mu\text{m}$
- Integrated CMOS camera with type-C connection
- Manually rotating mount for 1" or 0.5" optics

Abbreviations

*APC - Angled Physical Contact

*PC - Physical Contact

*FC - Ferrule Connector

*SM - Single-mode

*MM - Multi-mode

*BS - Beam Splitter

*FOV - Field Of View

www.multi-field.com | MultiFields Technologies

10.1 Raman Spectroscopy - Application

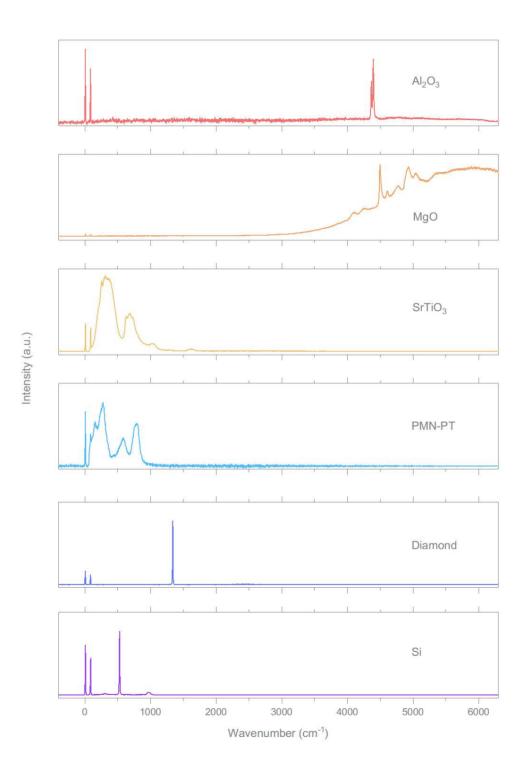
Fluorescence / Raman Module - Specifications

Basic Function	
Filter size	Φ < 25.4 mm, thickness < 6mm
Focused spot size	Φ < 1 um with LTAC objective @ 633 nm
Excitation wavelength	450 nm ∼ 700 nm
Fluorescence collection	single-mode or multi-mode fiber
Spectral resolution	0.02 nm
Transmission edges tuning	Rotatable filter mount allows easy tuning of transmission edges

Application (1)-

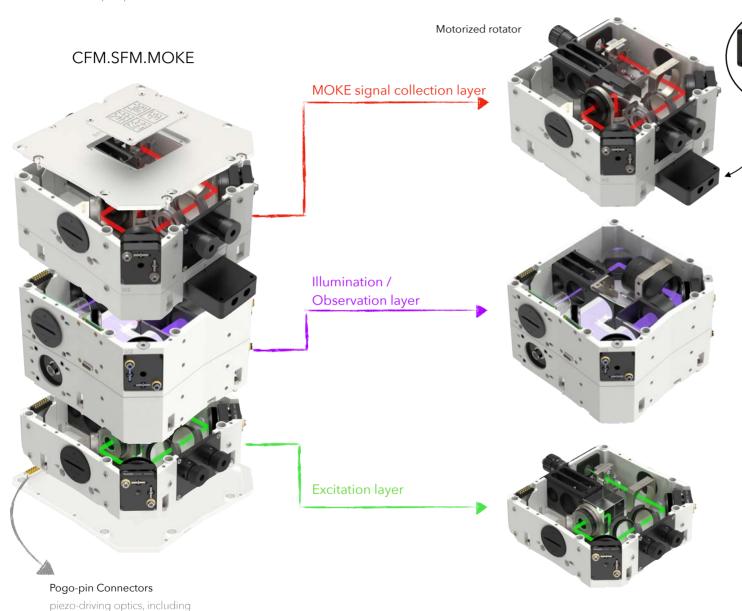
Raman spectra of several typical samples

Sample Information	Al ₂ O ₃ , MgO, SrTiO ₃ , PMN-PT, Diamond, Si
MultiFields Products	CFM system, CFM.Probe with Raman spectroscopy module
Instruments	532 nm CW excitation; LP03-532RE long-pass filter; PI HRS spectrometer 300 line/mm, Integration time 5s



10.2 SFM - MOKE Measurement

Integrated MOKE measurement module, which can be directly mounted on confocal sample probes



Photoelastic Modulator (PEM)

- Two characterization measurement modes in one setup:
- PEM-based single point mode

Key Features:

- Two characterization measurement modes in one setup:
- PEM-based single point mode
- Wide-field imaging mode hysterisis with modulation enhanced detection sensitivity
- Motorized rotators with precise angular positioning Accurate alignment of polarizers to the fast axis of PEM
- Imaging mode at 532 nm

Abbreviations

*MOKE - Magrceto-optical Kerr Effect

*PEM - Photoelastic Modulator

waveplate and polarizers

10.2 MOKE - Application

MOKE Module - Specification

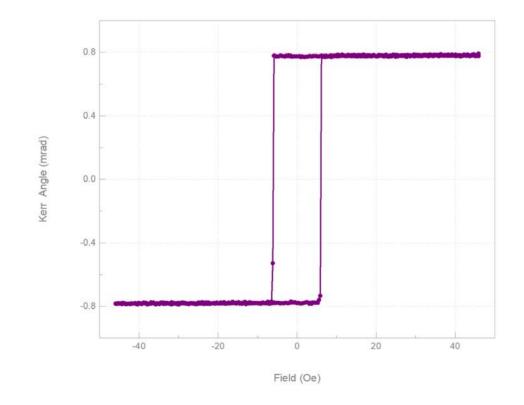
Basic Function	
Temperature range	4 K ~ 300 K
Detection noise	<1 mdeg (Kerr angle)
Reflectivity noise	< 0.05% rms
Focused spot size	Φ < 1 um with LTAC objective
Wavelength range	450 nm to 700 nm
Lens option	1. Single aspheric lens 2. High-NA low-temperature objective

Application (1)— MOKE Hysteresis loop of ferromagnetic thin film

Sample Information Si/SiO2//Ta(3)/CoFeB(1.1)/MgO(2)/Ta(2 nm)

MultiFields Products CFM system, CFM.Probe with MOKE module

Experiment conditions Polar configuration, 633nm CW excitation,



10.2 MOKE - Photoelastic Modulator (PEM)

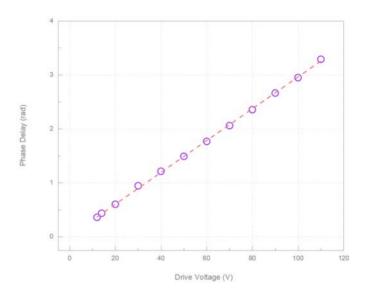
Compact photoelastic modulator that can be mounted on a confocal module or used as a stand-alone device



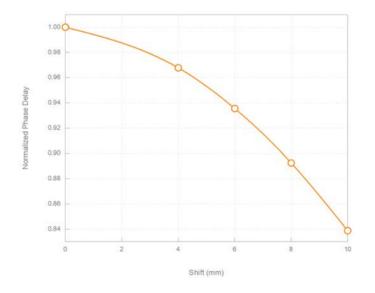
Photoelastic Modulator - Specification

基本参数	
Optical Material	Fused Silica
Nominal frequency	50 kHz
Transmission Range	200 nm ~ 2.6 um
Half-Wave Retardation	200 nm ~ 1 um
Clear Aperture (1)	Ф 16mm
Operating frequency	0.1 Hz ~ 200 kHz
Frequency lock resolution	0.03 Hz
Frequency display	1 Hz
Duty cycle, f and 2f	50% 0.001%
Operating temperature	0C ~ 50C
Power consumption	20 W
Weight	100 g
Size	30 mm * 100 mm *10 mm

Application (1)– Photoelastic Modulator Performance



• Wide-field imaging mode hysteresis with modulationPhase delay is the amplitude of phase oscillations induced by the PEM. Experimentally, the PEM is placed between two crossed polarizers and is oriented 45 degrees with respect to the first polarizer. The 633 nm transmitted laser light is detected by a photo diode and read out by a DAQ. Our PEM exhibits an excellent linear response to the driving voltage up to 200 Vpp.



• Due to the standing-wave nature of the PEM, the phase delay along the wave propagation direction cannot be a constant.Our PEM shows a useful optical aperture of 15 mm within which the delay variation is less than 10%.

■ Optical Measurement System

10.3 Confocal Optical Probe

Suitable for cryogenic confocal measurement and compatible with the most superconducting magnet platforms



• Multifields Technologies 25-mm positioning and scanning stages, suitable for dia. 50 mm cryogenic chambers

CFM.Probe.50Ox





CFM.Probe.26P

1	Model	CFM.Probe.50Ox	CFM.Probe.26P	
2	Function	Compatible with all stackable function modules and suitable for confocal scanning microscopy, confocal fluorescence/Raman spectroscopy, magneto-optical Kerr effect measurements		
3	Work environment	Temperature: 1.4 K ~ 400 K; Pressur	re: $10^5 \sim 10^{-5} \text{Pa}$; Magnetic Field: $0 \sim 18 \text{Tesla}$;	
4	Flange/Diameter	KF50 / dia-50 mm	KF40 / dia-26 mm & dia-30 mm	
5	Position range	x: 3mm; y: 3mm; z: 3mm	x: 2mm; y: 2mm; z: 2mm	
6	Position resolution	x: 1um; y: 1um; z: 1um	x: 1um; y: 1um; z: 1um	
7	Scan range	x: 3mm; y: 3mm; z: 3mm	x: 2mm; y: 2mm; z: 2mm	
8	Scan resolution	x: 1um; y: 1um; z: 1um	x: 1um; y: 1um; z: 1um	
9	Bore diameter	25.4 mm(1")	12.7 mm(0.5")	
10	Objective lens	Phi < 25.4 mm	Phi < 20 mm,M9 x 0.5 Threaded	
11	Sample space	X,Y < 9 mm,Z < 9 mm	X,Y < 10 mm,Z <10 mm	
12	Electric channel	12	16	

• Cage frame with SM1 optical apertures for mounting various optical elements



CFM.Spacer.50



CFM.Spacer.26

10.4 Low-Temperature Objective - LTAC Series

Optical objective for long-time stable working at low temperature

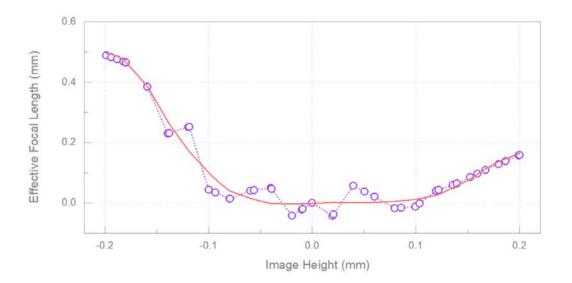


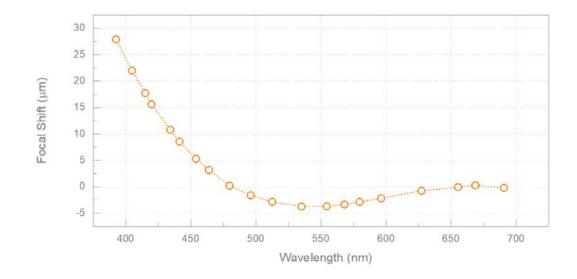


Infinite Conjugate Low-Temperature Objective (LTAC Series) Specifications

Basic Parameters	
Temperature range	down to 4 K
Pressure range	10-6 mbar ~ 1 bar
Magnetic field range	0 T ~ 14 T
Numerical aperture (NA)	0.85
Focal length (f)	3.1 mm
Working distance (WD)	0.4 mm
Magnification	X60 for 180mm tube lens
Back aperture	Ø 6.15 mm
Anti-reflective coating	400 ~ 1100 nm
Achromatic correction	450 ~ 800 nm
Case Material	Titanium

Application (1)– Performance of Infinite Conjugate Low-Temperature Objective

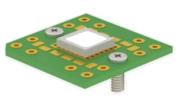




Materials Characterization

10.5 Sample Mount

Flexible and convenient sample mounting for combined opticalelectric measurements



• Sample Holder

A platform on which the sample is mounted and which can be removed for wire-bonding the sample.



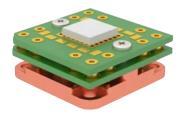
• Sample Base

12 pogo-pins are installed to ensure good electrical contact while maximizing sample space.

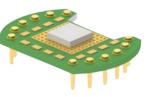


• Oxygen-free Copper Base

Ensures excellent thermal conductivity and incorporates a Cernox thermometer.



 Compact sample holder design for most combined optical-electric measurements.



• Sample Holder

A platform on which the sample is mounted and which can be removed for wire-bonding the sample.



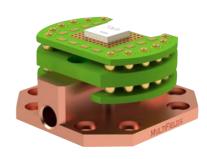
• Sample Base

12 circlip pins are installed to ensure good electrical contact while maximizing sample space.



• Oxygen-free Copper Base

Ensures thermal conductivity and incorporates a Cernox thermometer and heater for independent temperature control.



 Compact sample holder design for most combined optical-electric measurements.

&Group

10.6 Nano Motion Units - 16-mm Series

Ultra-precise nano-motion units using in minimum dia.26mm chamber

CFM·\$\phi\$25 - Piezoelectric Motion Units



Materials Characterizatio

10.6 Nano Motion Units - 25-mm Series

Ultra-precise nano-motion units suitable for dia.50mm chamber

CFM·Ф50 - Piezoelectric Motion Units



	Motion Unit	Work Environment	Dimension	Travel Range	Max Load	Dynamic Drive Force	Pins Number	Weight
→	Scanner25-z		25 * 25 * 12 mm	55 um	100 g		2 pins	20 g
→	Scanner25-xy		25 * 25 * 13.5 mm	55 * 55 um	100 g		4 pins	23 g
→	Linear25-z	1 K & 18 Tesla & 2m-7 mbar	25 * 25 * 19.5 mm	6 mm	300 g	4 N	Drive - 4 pins Sensor - 3 pins	34 g
→	Linear25-y		25 * 25 * 9.5 mm	6 mm	4 00 g	2 N	Drive- 2 pins Sensor - 3 pins	24 g
→	Linear25-x		25 * 25 * 9.5 mm	6 mm	400 g	2 N	Drive - 2 pins Sensor- 3 pins	24 g

10.6 Nano Motion Units - Controller

Precision motion solutions including instrumentation and software



Scanner Controller
MC - ArchimedesLT.03

*All data below is measured with 50 ohm wires. Though there is no requirement on wires' conductance, we recommend resistance below 50 ohm.

	Optional Versions ⇨	ArchimedesLT.03
1	Output channels	3 channels
2	Max output voltage	-150 V ~ +150 V
3	Drive frequency range	Max. 1kHz
4	Encoder	Capacity encoder
5	Sensor output voltage	DC 2.5 V
6	Resolution of read voltage	50 uF (18-bit)
7	Connectors	3 channels, BNC
8	Input resistance	10 kOhm
9	Compatible Scanners	Scanner16-xy, Scanner16-z, Scanner25-xy, Scanner25-z,



Positioner Controller MC - NewtonLT.06

*All data below is measured with 50 ohm wires. Though there is no requirement on wires' conductance, we recommend resistance below 50 ohm.

	Optional Versions ⇨	MC - NewtonLT.06
1	Output channels	6 channels
2	Max output voltage	-200 V ~ +200 V
3	Drive frequency range	1 ~ 10 kHz
4	Encoder	Resistive encoder
5	Sensor output voltage	DC 2.5 V
6	Resolution of read voltage	50 uF (18-bit)
7	Connectors	6 channels
8	Input resistance	10 kOhm
9	Compatible Positioners	Positioner 16-xy, Positioner 16-z, Positioner 25-xy, Positioner 25-z,

"Kelvinion Series" Temperature Monitor & Control Products









	Kelvinion Controller	Kelvinion mini Controller	Kelvinion Monitor	Kelvinion Monitor. X					
Product Number	MKC-08	MKC-02	MKM-12	MKM-2-X					
	8	2	12	2N					
Number of Input	8 independent input channels, instead of 3 independent + 5 switching chnnels	2 independent input channels	2 independent input channels	Input can be freely configured to desired number of channels and max. 32 independent monitoring channels.					
Control Channel	2	1	/	/					
Temperature Monitoring									
Supported sensor		Resistive, diode tempera	ature sensor						
User Curves		> 1000							
Lower Limit									
Measurement Type		Variable DC current source; Current is automatically tuned upon ranges							
Min Current		100 nA							
Precision with 100-nA Current		1.5 Ω + 50 ppm of rdg							
TC Output									
Max Power	100 W + 50 W	100 W	1	1					
Heating Range	3	3	/	/					
Communication Interface									
LAN									
Serial Port (USB)		Yes							
GPIB	Yes		N. A.						
RS-485	N. A.		Yes						

11.1 Temperature Controller · Kelvinion mini

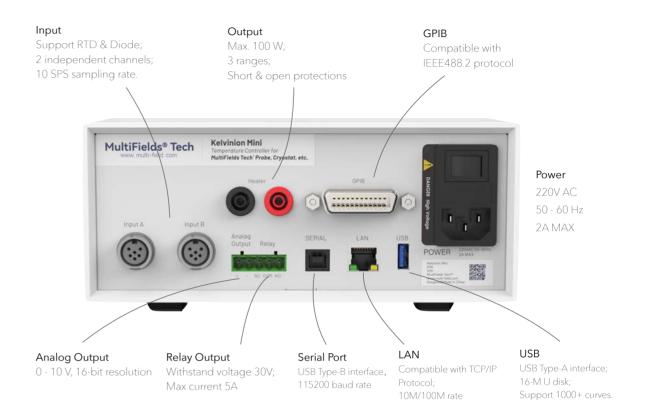
Maximum 100 W power output and minimum 300 mK controlled temperature



Temperature Controller · Kelvinion mini

Key Features

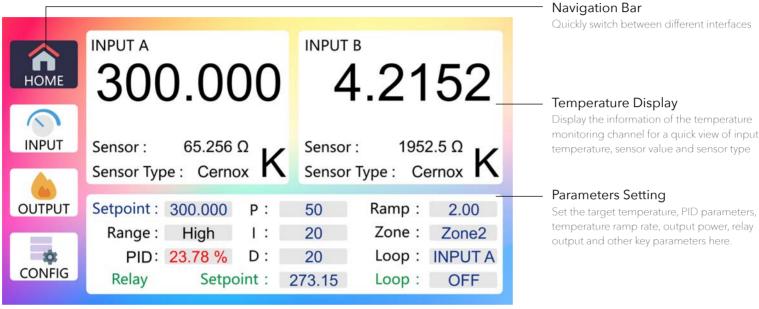
- Temperature range of measurement and control down to 300 mK;
- 2 independent monitoring channels with 0.1 mK resolution (24-bit ADC);
- Automatic tuning of the excitation current for higher accuracy and lower heating;
- Supports 1000+ user-defined curves;
- 1 PID output channel with 100 W power output;
- Supports 1 relay and 1 analog signal outputs;
- Supports setting temperature ramp rate;
- PID parameters can be switched according to the zone table for different temperature ranges (Zone mode);
- Support USB (serial port), LAN and GPIB communications;
- Automatic protections such as heater short and open detection, setpoint limits are supported.



Diode and resistive sensors (PTC or NTC) have become the preferred solution for temperature monitoring at low temperature and in environments with strong magnetic fields. MultiFields Technologies designed the "Kelvinion mini", a compactly designed cryogenic temperature controller. It consists of 2 independent high-precision temperature monitoring channels and one high-power PID output channel (100 W), as well as one relay output and one analog output channel. The PID closed-loop control, Zone mode, variable temperature rate setting and active over-temperature detection, make the Kelvinion mini cryogenic temperature controller a great tool for low-temperature researches.

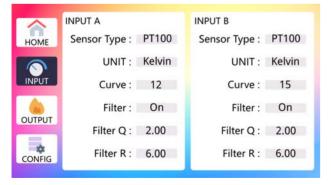
11.1 Kelvinion mini - Touch-screen Interface

Touch-operated temperature controller interface, quick and easy to use



HOME Interface

This interface displays the current temperature, setpoint of temperature, PID parameters, temperature ramp rate, and output power, etc..



INPUT Interface

This interface allows the user to set the sensor type, display unit, calibration curve and filter parameters for the input channel.



OUTPUT Interface

This interface allows the user to set parameters such as PID output, relay output, safe temperature, ZONE mode, etc...



CONFIG Interface

This interface allows the user to set communication modes, GPIB and IP address.

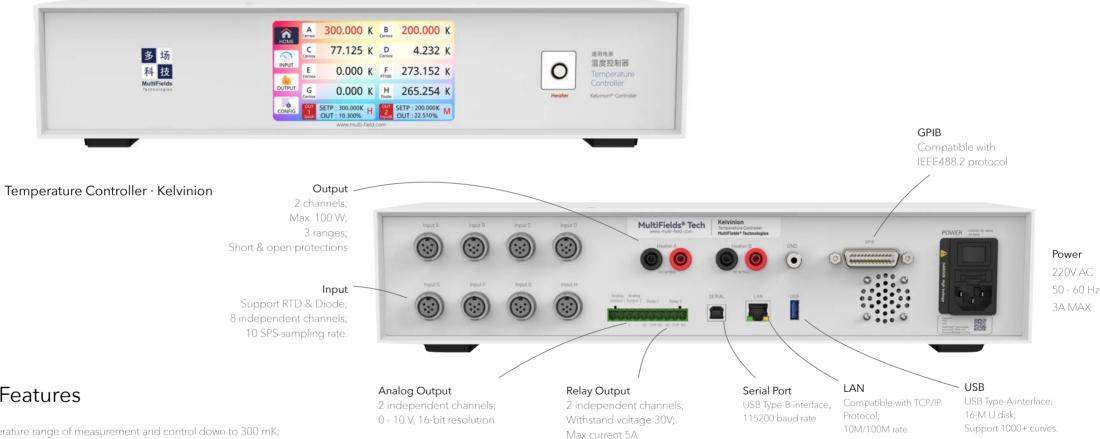
11.1 Kelvinion mini - Specifications

Input										
Number of Input	2									
Isolation	Sensors inputs optically isolated from other circuits									
ADC Resolution		24 bit								
Max update rate		10 reads/s on each input								
User Curves		1000+ curves (400 points Max in single curve)								
Filter				K	alman Filte	r				
Input Specifications										
Sensor Type					Diode / RTD)				
Measurement Type		4 leads								
Excitation		Constant current with current reversal for RTDs								
Supported Sensors		Diodes: Si, GaAlAs; RTDs: 100 Ω & 1000 Ω Pt, Ge, Carbon-Glass, Cernox®, and Rox $^{\text{TM}}$								
NTC-Input Range	0 ~10 Ω	0 ~30 Ω	0 ~100 Ω	0 ~300 Ω	0 ~1 kΩ	0 ~3 kΩ	0 ~10 kΩ	0 ~30 kΩ	0 ~100 kΩ	
NTC-Excitation Current	1 mA	0.3 mA	0.1 mA	30 μΑ	10 μΑ	3 μΑ	1 μΑ	0.3 μΑ	0.1 μΑ	
NTC-Measurement Resolution	0.15 mΩ	0.45 mΩ	1.5 mΩ	4.5 mΩ	15 mΩ +0.02‰ of rdg	45 mΩ +0.02‰ of rdg	150 mΩ +0.02‰ of rdg	450 mΩ +0.02‰ of rdg	1.5 Ω +0.05‰ of rdg	
NTC-Accuracy	8 mΩ	20 mΩ	50 mΩ	120 mΩ	0.5 Ω +0.02‰ of rdg	1.2 Ω +0.02‰ of rdg	5 Ω +0.02‰ of rdg	15 Ω +0.02‰ of rdg	15 Ω +0.05‰ of rdg	
Control										
Control Loops					1					
PID Tuning				Autotune	(one loop a	at a time)				
PID Parameters	P (Gain): 0 to 1000 with 0.01 setting resolution I (Reset): 0 to 1000 with 0.01 setting resolution D(Rate): 0 to 200 % with 0.01% setting resolution Manual output: 0 to 100% with 0.01 setting resolution									
Zone Mode		5 temperature zones with PID and heater range								
Setpoint Ramping		0.1 K/min ~ 20 K/min								

Output Loop	25-Ω Heater	50-Ω Heater				
Output Type	Variable DC current source					
DAC Resolution	16 k	pit				
Max. Power	100 W	50 W				
Max. Current	2 A	1 A				
Voltage Compliance	50	V				
Heater Load Range	10 to 1	00 Ω				
Output Range	3					
General						
Relay Output	1					
Analog Output	1, 0~10\	V, 16 bit				
Communication	Serial port (USB): USB-TypeB interface, baud rate: 115200 GPIB: IEEE488.2, support setting address LAN: TCP/IP, 10M/100M rate, support setting address and pot					
Display	5.0 inch TFT touch-screen with 1280 x 720 pixels					
Safety Limit	Short & open circuit protection Setpoint & temperature limit protection					
Size	215(W) * 88.9(H) * 358(L) (unit: mm)					

11.2 Temperature Controller · Kelvinion

8 independent temperature monitoring channels & 2 temperature control channels, max. power 100 + 50 W



Key Features

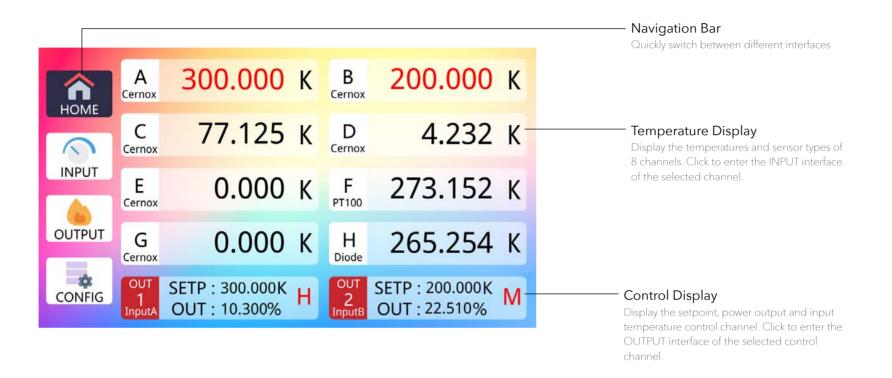
- Temperature range of measurement and control down to 300 mK;
- 8independent monitoring channels with 0.1 mK resolution (24-bit ADC);
- Automatic tuning of the excitation current for higher accuracy and lower heating;
- Supports 1000+ user-defined curves;
- 2 PID output channel with 100 W power output;
- Supports 2 relay and 2 analog signal outputs;
- Supports setting temperature ramp rate;
- PID parameters can be switched according to the zone table for different temperature ranges (Zone mode);
- Support USB (serial port), LAN and GPIB communications;
- Automatic protections such as heater short and open detection, setpoint limits are supported.

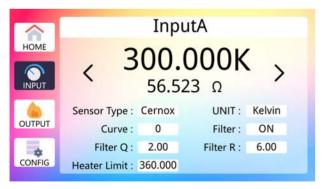
MultiFields Technologies designed the "Kelvinion", a powerful cryogenic temperature controller. It consists of 8 independent high-precision temperature monitoring channels and 2 high-power PID output channel (100 + 50 W), as well as 2 relay output and 2 analog output channel. The PID closed-loop control, Zone mode, variable temperature rate setting and active over-temperature detection, make the Kelvinion mini cryogenic temperature controller a great tool for lowtemperature researches.

General instruments - 2. Relvinion

11.2 Kelvinion - Touch-screen Interface

Touch-operated temperature controller interface, quick and easy to use





INPUT Interface

This interface displays the temperature and sensor value, allows the user to set the sensor type, display unit, calibration curve, filter parameters and heater limit for the input channel.



OUTPUT Interface

This interface allows the user to set parameters such as PID output, relay output, safe temperature, ZONE mode, etc.. Users can also enter the PID autotune interface.



CONFIG Interface

This interface allows the user to set communication modes, GPIB and IP address.

11.2 Kelvinion - Specifications

Input										
Number of Input	8									
Isolation	Sensors inputs optically isolated from other circuits									
ADC Resolution		24 bit								
Max update rate		10 reads/s on each input								
User Curves			1000-	+ curves (40	0 points Ma	x in single o	curve)			
Filter				K	alman Filte	r				
Input Specifications										
Sensor Type					Diode / RTD)				
Measurement Type					4 leads					
Excitation			Const	ant current	with current	reversal for	RTDs			
Supported Sensors		Diodes: Si, GaAlAs; RTDs: 100 Ω & 1000 Ω Pt, Ge, Carbon-Glass, Cernox®, and Rox™								
NTC-Input Range	0 ~10 Ω	0 ~30 Ω	0 ~100 Ω	0 ~300 Ω	0 ~1 kΩ	0 ~3 kΩ	0 ~10 kΩ	0 ~30 kΩ	0 ~100 kΩ	
NTC-Excitation Current	1 mA	0.3 mA	0.1 mA	30 μΑ	10 μΑ	3 μΑ	1 μΑ	0.3 μΑ	0.1 μΑ	
NTC-Measurement Resolution	0.15 mΩ	0.45 mΩ	1.5 mΩ	4.5 mΩ	15 mΩ +0.02‰ of rdg	45 mΩ +0.02‰ of rdg	150 mΩ +0.02‰ of rdg	450 mΩ +0.02‰ of rdg	1.5 Ω +0.05‰ of rdg	
NTC-Accuracy	8 mΩ	20 mΩ	50 mΩ	120 mΩ	0.5 Ω +0.02‰ of rdg	1.2 Ω +0.02‰ of rdg	5 Ω +0.02‰ of rdg	15 Ω +0.02‰ of rdg	15 Ω +0.05‰ of rdg	
Control										
Control Loops					2					
PID Tuning		Autotune (one loop at a time)								
PID Parameters		P (Gain): 0 to 1000 with 0.01 setting resolution I (Reset): 0 to 1000 with 0.01 setting resolution D(Rate): 0 to 200 % with 0.01% setting resolution Manual output: 0 to 100% with 0.01 setting resolution								
Zone Mode		5 temperature zones with PID and heater range								
Setpoint Ramping				0.1 K/	′min ∼ 20 k	/min				

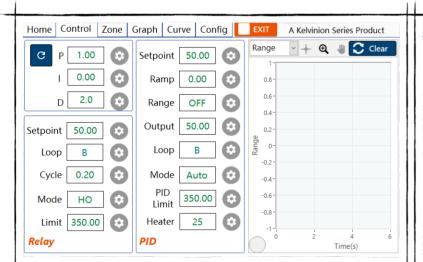
Output Loop 1	25-Ω Heater	50-Ω Heater
Output Type	Variable DC c	urrent source
DAC Resolution	16	bit
Max. Power	100 W	50 W
Max. Current	2 A	1 A
Voltage Compliance	50	V
Heater Load Range	10 to	100 Ω
Output Range	3	}
Output Loop 2	25-Ω Heater	50-Ω Heater
Output Type	Variable DC c	urrent source
DAC Resolution	16	bit
Max. Power	50 W	25 W
Max. Current	1.4 A	1 A
Voltage Compliance	50	V
Heater Load Range	10 to	100 Ω
Output Range	3	}
General		
Relay Output	1	
Analog Output	1, 0~10	V, 16 bit
Communication	Serial port (USB): USB-TypeB GPIB: IEEE488.2, su LAN: TCP/IP, 10M/100M rate,	ipport setting address
Display	5.0 inch TFT touch-scree	n with 1280 x 720 pixels
Storage	16 M,PC driver	-free connection
Safety Limit	Short & open ci Setpoint & tempera	
Size	430(W) * 88.9(H) * 3	358(L) (unit: mm)

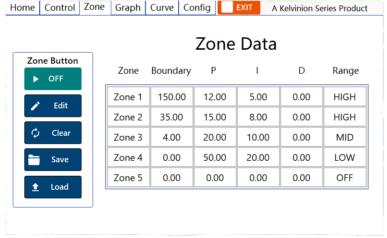
11.2 PC Software - Kelvinion Series- Controller

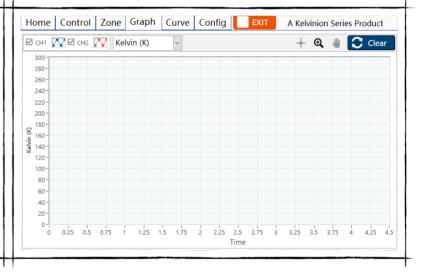
Provide dedicated operating software, complete communication commands and LabVIEW drivers

PC Software

Kelvinion temperature controllers are supported by a computer software, which can configure all parameters of the instrument and support functions such as calibration curve editing and uploading. Users can realize remote control of Kelvinion. In addition, a set of communication commands and LabVIEWTM drivers are available to help professional users quickly integrate Kelvinion into their systems.







Control Interface

This interface allows user to set the temperature control parameters of the controller and display them in the figure on the right.

Zone Interface

In this interface, users can set the control parameters under different ZONE, and can save the above parameters locally or import them into a new controller.

Graph Interface

Historical temperature profiles are displayed on this interface and the data can be saved locally.

■ General Instruments - 3. Kelvinion Monitor

11.3 Temperature Monitor \cdot Kelvinion Monitor

Standard 12 independent monitoring channels. Support 2-32 independent monitoring channels.

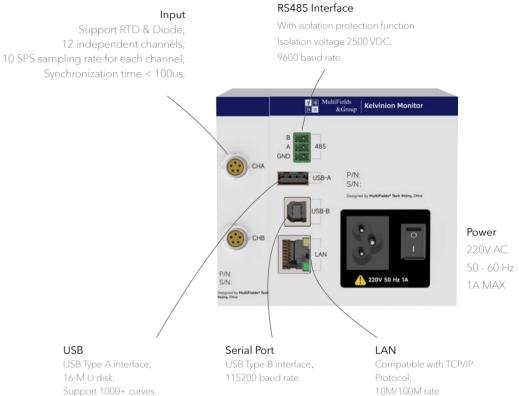


Temperature Monitor · Kelvinion Monitor

Temperature Monitor · Kelvinion Monitor. X

Key Features

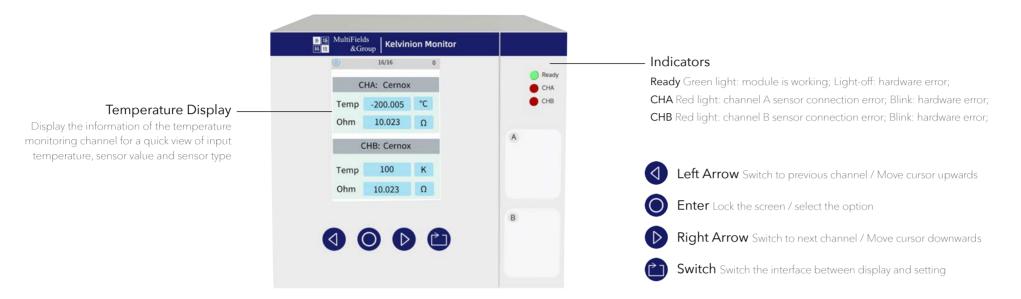
- Temperature range of measurement and control down to 300 mK with 0.1 mK resolution (24-bit ADC)
- Standard 12 independent monitoring channels. Support 2-32 independent monitoring channels;
- Each channel is isolated from the other, with a sampling rate of 10 SPS.
- Support synchronous sampling function, the synchronization time is better than
- Automatic tuning of the excitation current for higher accuracy and lower heating;
- Supports 1000+ user-defined curves;
- Support USB (serial port), LAN and RS485 communications;



In large cryogenic installations, it is necessary to monitor the temperatures at several positions simultaneously. To meet the multi-channel temperature monitoring requirement, MultiFields Technologies designed the "Kelvinion Monitor". It consists of 12 independent high-precision temperature monitoring channels with 10 SPS sampling rate and synchronous sampling function. The unique design allows us to freely extend the number of monitoring channel from 2 to 32. It is also compatible with the standard cabinets.

11.3 Kelvinion Monitor - Interface and Control

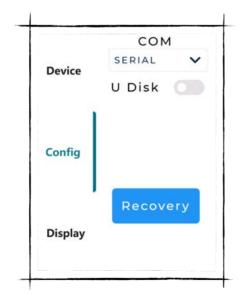
Flexible to increase or decrease monitoring channels





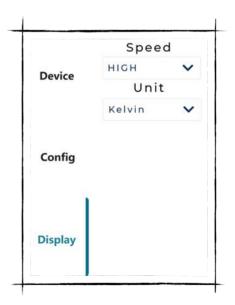
Device Interface

Set the sensor type, calibration curve and filter parameters for each channel.



Config Interface

Set the instrument communication mode and set the USB memory function on or off.



Display Interface

Set the temperature display interface scrolling speed and display unit.

11.3 Kelvinion Monitor - Specifications

$\label{temperature Monitor} \textbf{Temperature Monitor} \cdot \textbf{Kelvinion Monitor} \cdot \textbf{Specifications}$

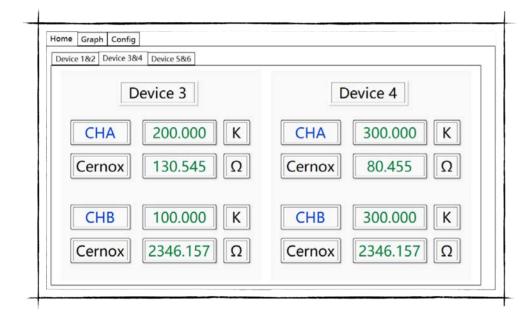
Input										
Number of Input	8									
Isolation	Sensors inputs optically isolated from other circuits									
ADC Resolution		24 bit								
Max update rate		10 reads/s on each input								
User Curves		1000+ curves (400 points Max in single curve)								
Filter				k	alman Filte	-				
Synchronization Time					< 100 µs					
Input Specifications										
Sensor Type		Diode / RTD								
Measurement Type		4 leads								
Excitation		Constant current with current reversal for RTDs								
Supported Sensors		Diodes: Si, GaAlAs; RTDs: 100 Ω & 1000 Ω Pt, Ge, Carbon-Glass, Cernox®, and Rox™								
NTC-Input Range	0 ~10 Ω									
NTC-Excitation Current	1 mA						0.1 μΑ			
NTC-Measurement Resolution	0.15 mΩ	0.45 mΩ	1.5 mΩ	4.5 mΩ	15 mΩ +0.02‰ of rdg	45 mΩ +0.02‰ of rdg	150 mΩ +0.02‰ of rdg	450 mΩ +0.02‰ of rdg	1.5 \Omega +0.05\% of rdg	
NTC-Accuracy	$8 \text{ m}\Omega$ $20 \text{ m}\Omega$ $50 \text{ m}\Omega$ $120 \text{ m}\Omega$ $+0.02\%$								15 Ω +0.05‰ of rdg	
General										
Communication	Serial port (USB): USB-TypeB interface, baud rate: 115200; LAN: TCP/IP, 10M/100M rate, support setting address and pot; RS-485: With isolation protection function; Isolation voltage 2500 VDC, 9600 baud rate									
Display	2.4 inch screen with 320 x 240 pixels									
Size	Host: 79(W) * 88.9(H) * 135(L) (unit: mm) Subs: 22.5(W) * 88.9(H) * 135(L) (unit: mm)									

11.3 PC Software - Kelvinion Series - Monitor

Provide dedicated operating software, complete communication commands and LabVIEW drivers

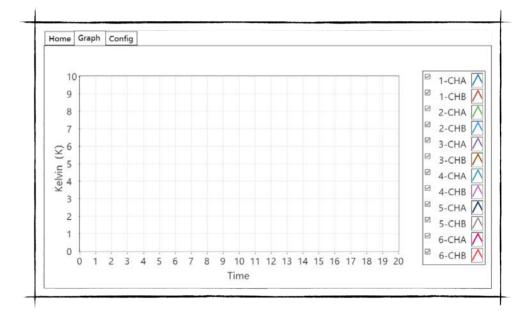
PC Software

Kelvinion temperature controllers are supported by a computer software, which can configure all parameters of the instrument and support functions such as calibration curve editing and uploading. Users can realize remote control of Kelvinion. In addition, a set of communication commands and LabVIEWTM drivers are available to help professional users quickly integrate Kelvinion into their systems.



Home - Device Interface

Display the information of the temperature monitoring channel for a quick view of input temperature, sensor value and sensor type



Graph Interface

Historical temperature profiles are displayed on this interface and the data can be saved locally.

MultiFields Technologies Co., Ltd.

5th Floor, 2# Building
Industry Park of Nonferrous Metal-Research Institute
Huairou Science City
Huairou District, Beijing, China

www.multi-field.com info@multi-field.com +86 18610278097 多场低温科技(北京)有限公司

北京市

怀柔区科学城

有色金属研究院园区2号楼5层

